



Report No.: RZA1103-0408HAC01



# ANSI C63.19

## TEST REPORT

|              |                                  |
|--------------|----------------------------------|
| Product Name | CDMA 1X Digital Mobile Telephone |
| Model        | HUAWEI M635                      |
| FCC ID       | QISC6071                         |
| Client       | Huawei Technologies Co., Ltd.    |

TA Technology (Shanghai) Co., Ltd.



## GENERAL SUMMARY

|                              |   |                   |                   |
|------------------------------|---|-------------------|-------------------|
| <b>Product Name</b>          | CDMA 1X Digital Mobile Telephone  | <b>Model</b>      | HUAWEI M635       |
| <b>FCC ID</b>                | QISC6071  | <b>Report No.</b> | RZA1103-0408HAC01 |
| <b>Client</b>                | Huawei Technologies Co., Ltd.   |                   |                   |
| <b>Manufacturer</b>          | Huawei Technologies Co., Ltd.   |                   |                   |
| <b>Reference Standard(s)</b> | <b>ANSI C63.19-2007:</b> American National Standard Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.   |                   |                   |
| <b>Conclusion</b>            | <p>This portable wireless equipment has been measured in all cases requested by the relevant standards.</p> <p>General Judgment: <b>M4 (RF Emission)</b></p> <p style="text-align: right;">(Stamp)</p> <p style="text-align: right;"><b>Date of issue: April 7<sup>th</sup>, 2011</b></p> |                   |                   |
| <b>Comment</b>               | The test result only responds to the measured sample.   |                   |                   |

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**TA Technology (Shanghai) Co., Ltd.**  
**Test Report**

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## 1. General Information

### 1.1. Notes of the Test Report

**TA Technology (Shanghai) Co., Ltd.** guarantees the reliability of the data presented in this test report, which is the results of measurements and tests performed for the items under test on the date and under the conditions stated in this test report and is based on the knowledge and technical facilities available at TA Technology (Shanghai) Co., Ltd. at the time of execution of the test.

**TA Technology (Shanghai) Co., Ltd.** is liable to the client for the maintenance by its personnel of the confidentiality of all information related to the items under test and the results of the test. This report only refers to the item that has undergone the test.

This report standalone dose not constitute or imply by its own an approval of the product by the certification Bodies or competent Authorities. This report cannot be used partially or in full for publicity and/or promotional purposes without previous written approval of **TA Technology (Shanghai) Co., Ltd.** and the Accreditation Bodies, if it applies.

If the electrical report is inconsistent with the printed one, it should be subject to the latter.

### 1.2. Testing Laboratory

Company: TA Technology (Shanghai) Co., Ltd.  
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### 1.3. Applicant Information

Company: Huawei Technologies Co., Ltd.  
Address: Bantian, Longgang District  
City: Shenzhen  
Postal Code: 518129  
Country: P.R. China  
Contact: Wang Yue  
Telephone: 0755-28780808  
Fax: 0755-28780808

### 1.4. Manufacturer Information

Company: Huawei Technologies Co., Ltd.  
Address: Bantian, Longgang District  
City: Shenzhen  
Postal Code: 518129  
Country: P.R. China  
Telephone: 0755-28780808  
Fax: 0755-28780808

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### 1.5. Information of EUT

#### General Information

|  |   |   |                                  |
|--|---|---|----------------------------------|
| Device Type:                           | Portable Device                                       |   |                                  |
| Product Name:                          | CDMA 1X Digital Mobile Telephone                      |   |                                  |
| MEID:                                  | A000002D241C54  |   |                                  |
| Hardware Version:                      | Ver.B   |   |                                  |
| Software Version:                      | M635C45B105   |   |                                  |
| Antenna Type:                          | Internal Antenna                                      |   |                                  |
| Device Operating Configurations:       |   |   |                                  |
| Supporting Mode(s):                    | CDMA Cellular (tested)                                |   |                                  |
|  | CDMA PCS (tested)                                     |   |                                  |
|  | CDMA AWS (tested)                                     |   |                                  |
|  | Bluetooth   |   |                                  |
| Test Modulation:                       | QPSK  |   |                                  |
| Operating Frequency Range(s):          | Mode  | Tx (MHz)                                    | Rx (MHz)                         |
|  | CDMA Cellular   | 824.7 ~ 848.31                              | 869.7 ~ 893.31                   |
|  | CDMA PCS  | 1851.25 ~ 1908.75                           | 1931.25 ~ 1988.75                |
|  | CDMA AWS  | 1711.25 ~ 1752.5                            | 2111.25 ~ 2152.5                 |
| Test Channel:<br>(Low - Middle - High) | 1013 - 384 - 777<br>25 - 600 - 1175<br>25 - 450 - 850 | (CDMA Cellular)<br>(CDMA PCS)<br>(CDMA AWS) | (tested)<br>(tested)<br>(tested) |
| Power Class:                           | CDMA Cellular: Tested with Power Control All up bits  |   |                                  |
|  | CDMA PCS: Tested with Power Control All up bits       |   |                                  |
|  | CDMA AWS: Tested with Power Control All up bits       |   |                                  |

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### Auxiliary Equipment Details

#### AE1:Battery

Model: HB5D1H  
Manufacturer: Huawei Technologies Co., Ltd.  
S/N: YHCAC31HI5305048

Equipment Under Test (EUT) is a model of CDMA 1X Digital Mobile Telephone. The detail about Mobile phone and Lithium Battery is in chapter 1.5 in this report. HAC is tested for CDMA Cellular, CDMA PCS and CDMA AWS. The EUT has a CDMA antenna that is used for Tx/Rx, and the other is BT antenna.

The sample under test was selected by the Client.

Components list please refer to documents of the manufacturer.

### 1.6. The Ambient Conditions during Test

|   |                           |
|---|---------------------------|
| Temperature   | Min. = 18°C, Max. = 28 °C |
| Relative humidity   | Min. = 0%, Max. = 80%     |
| Ground system resistance  | < 0.5 Ω                   |
| Ambient noise is checked and found very low and in compliance with requirement of standards.<br>Reflection of surrounding objects is minimized and in compliance with requirement of standards. |                           |

### 1.7. The Total M-rating of each tested band

| Band          | Rating    |
|---------------|-----------|
| CDMA Cellular | <b>M4</b> |
| CDMA PCS      | <b>M4</b> |
| CDMA AWS      | <b>M4</b> |

### 1.8. Test Date

The test is performed from April 2, 2011 to April 3, 2011.

## **2. Test Information**

### **2.1. Operational Conditions during Test**

#### **2.1.1. General Description of Test Procedures**

The phone was tested in all normal configurations for the ear use. The EUT is mounted in the device holder equivalent as for classic dosimeter measurements. The acoustic output of the EUT shall coincide with the center point of the area formed by the dielectric wire and the middle bar of the arch's top frame. The EUT shall be moved vertically upwards until it touches the frame. The fine adjustment is possible by sliding the complete. The EUT holder is on the yellow base plate of the Test Arch phantom. These test configurations are tested at the high, middle and low frequency channels of each applicable operating mode; for example, GSM, WCDMA (UMTS), CDMA and TDMA.

#### **2.1.2. CDMA Test Configuration**

A communication link is set up with a System Simulator (SS) by air link, and a call is established. The Absolute Radio Frequency Channel Number (ARFCN) are allocated to 1013, 384 and 777 respectively in the case of CDMA Cellular, allocated to 25, 600 and 1175 respectively in the case of CDMA PCS, allocated to 25, 450 and 850 respectively in the case of CDMA AWS, The EUT is commanded to operate at maximum transmitting power.

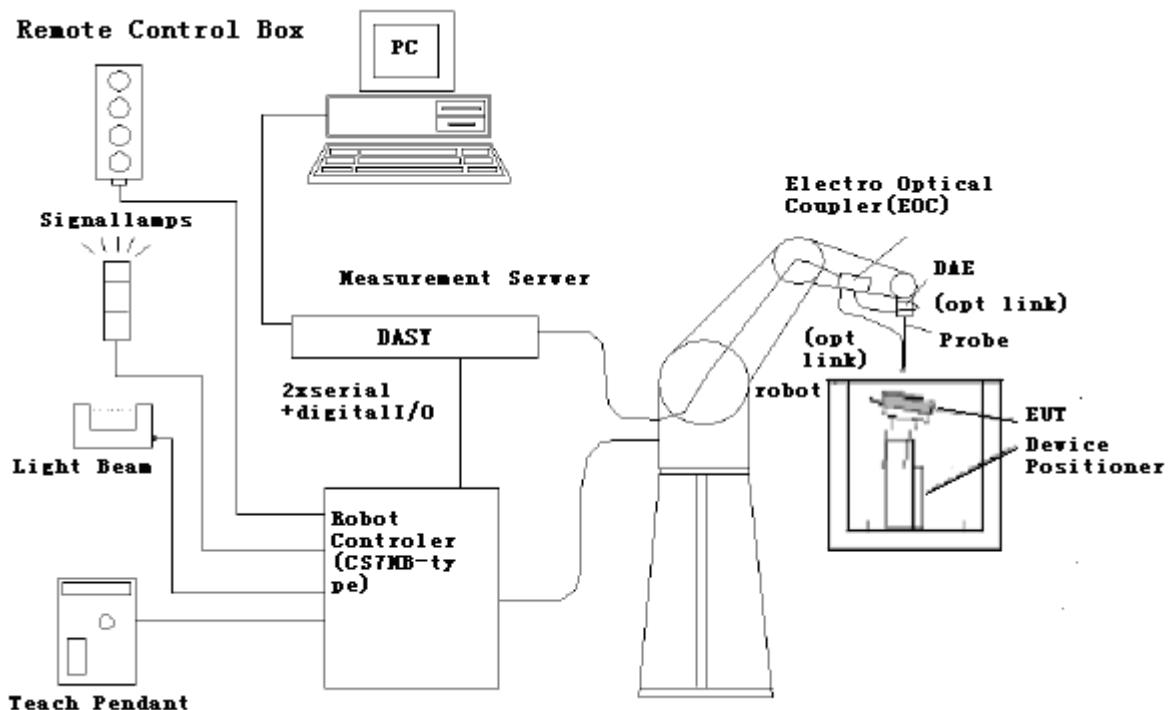
Test Parameter setup for maximum RF output power according to section 4.4.5 of 3GPP2.

| Parameter        | Units       | Value |
|------------------|-------------|-------|
| I or             | dBm/1.23MHz | -104  |
| PilotE c /I or   | dB          | -7    |
| TrafficE c /I or | dB          | -7.4  |

## 2.2. HAC RF Measurements System Configuration

### 2.2.1. HAC Measurement Set-up

These measurements are performed using the DASY5 automated dosimetric assessment system. It is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists of high precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-field probe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. Cell controller systems contain the power supply, robot controller, teach pendant (Joystick) and remote control, and are used to drive the robot motors. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit performs the signal amplification; signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.



**Figure 1 HAC Test Measurement Set-up**

The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.

## 2.2.2. Probe System

The HAC measurements were conducted with the E-Field Probe ER3DV6 and the H-Field Probe H3DV6 (manufactured by SPEAG), designed in the classical triangular configuration and optimized for dosimetric evaluation.

### E-Field Probe Description

|               |   |
|---------------|---|
| Construction  | One dipole parallel, two dipoles normal to probe axis<br>Built-in shielding against static charges<br>PEEK enclosure material |
| Calibration   | In air from 100 MHz to 3.0 GHz (absolute accuracy $\pm 6.0\%$ , $k=2$ )   |
| Frequency     | 40 MHz to $> 6$ GHz (can be extended to $< 20$ MHz)<br>Linearity: $\pm 0.2$ dB (100 MHz to 3 GHz)                             |
| Directivity   | $\pm 0.2$ dB in air (rotation around probe axis)<br>$\pm 0.4$ dB in air (rotation normal to probe axis)                       |
| Dynamic Range | 2 V/m to $> 1000$ V/m; Linearity: $\pm 0.2$ dB  |
| Dimensions    | Overall length: 330 mm (Tip: 16 mm)<br>Tip diameter: 8 mm (Body: 12 mm)<br>Distance from probe tip to dipole centers: 2.5 mm  |
| Application   | General near-field measurements up to 6 GHz<br>Field component measurements<br>Fast automatic scanning in phantoms            |



**Figure 2 ER3DV6 E-field Probe**

### H-Field Probe Description

|                      |   |
|----------------------|---|
| Construction         | Three concentric loop sensors with 3.8 mm loop diameters<br>Resistively loaded detector diodes for linear response<br>Built-in shielding against static charges<br>PEEK enclosure material (resistant to organic solvents, e.g., glycolether) |
| Frequency            | 200 MHz to 3 GHz (absolute accuracy $\pm 6.0\%$ , $k=2$ );<br>Output linearized   |
| Directivity          | $\pm 0.2$ dB (spherical isotropy error)   |
| Dynamic Range        | 10 mA/m to 2 A/m at 1 GHz   |
| E-Field Interference | < 10% at 3 GHz (for plane wave)   |
| Dimensions           | Overall length: 330 mm (Tip: 40 mm)<br>Tip diameter: 6 mm (Body: 12 mm)<br>Distance from probe tip to dipole centers: 3 mm  |



**Figure 3 H3DV6 H-field Probe**

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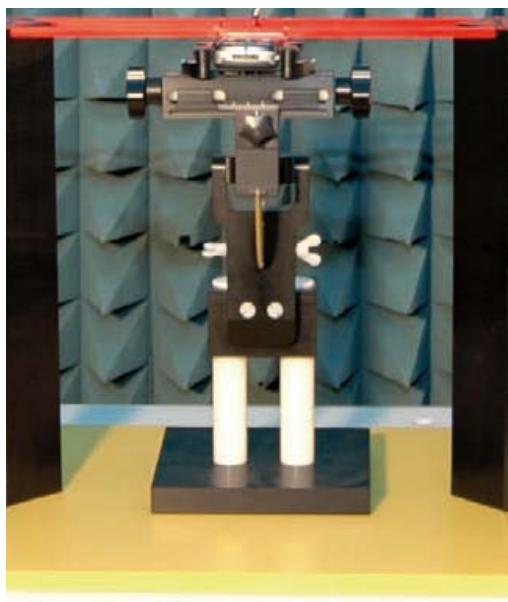
|             |   |
|-------------|---|
| Application | General magnetic near-field measurements up to 3 GHz (in air or liquids)<br>Field component measurements<br>Surface current measurements<br>Low interaction with the measured field |
|-------------|---|

### 2.2.3. Test Arch Phantom & Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions: 370 x 370 x 370 mm).

The Device reference point is set for the EUT at 6.3 mm, the Grid reference point is on the upper surface at the origin of the coordinates, and the “user point \Height Check 0.5 mm” is 0.5mm above the center, allowing verification of the gap of 0.5mm while the probe is positioned there.

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field  $<\pm 0.5$  dB.



**Figure 4 HAC Phantom & Device Holder**

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### 2.3. RF Test Procedures

**The evaluation was performed with the following procedure:**

1. Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.
2. Position the WD in its intended test position. The gauge block can simplify this positioning. Note that a separate E-field and H-field gauge block will be needed if the center of the probe sensor elements is at different distances from the tip of the probe.
3. Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters (e.g., test mode), as intended for the test.
4. The center sub-grid shall center on the center of the axial measurement point or the acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane. If the field alignment method is used, align the probe for maximum field reception.
5. Record the reading.
6. Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading at each measurement point. The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
7. Identify the five contiguous sub-grids around the center sub-grid with the lowest maximum field strength readings. Thus the six areas to be used to determine the WD's highest emissions are identified and outlined for the final manual scan. Please note that a maximum of five blocks can be excluded for both E-field and H-field measurements for the WD output being measured. Stated another way, the center sub-grid and three others must be common to both the E-field and H-field measurements.
8. Identify the maximum field reading within the non-excluded sub-grids identified in Step 7.
9. Convert the maximum field strength reading identified in Step 8 to V/m or A/m, as appropriate. For probes which require a probe modulation factor, this conversion shall be done using the appropriate probe modulation factor and the calibration.
10. Repeat Step 1 through Step 10 for both the E-field and H-field measurements.
11. Compare this reading to the categories in ANSI C63.19 Clause 7 and record the resulting category. The lowest category number listed in 7.2, Table 7.4, or Table 7.5 obtained in Step 10 for either E- or H-field determines the M category for the audio coupling mode assessment. Record the WD category rating.

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Figure 5 WD reference and plane for RF emission measurements

## 2.4. System Check

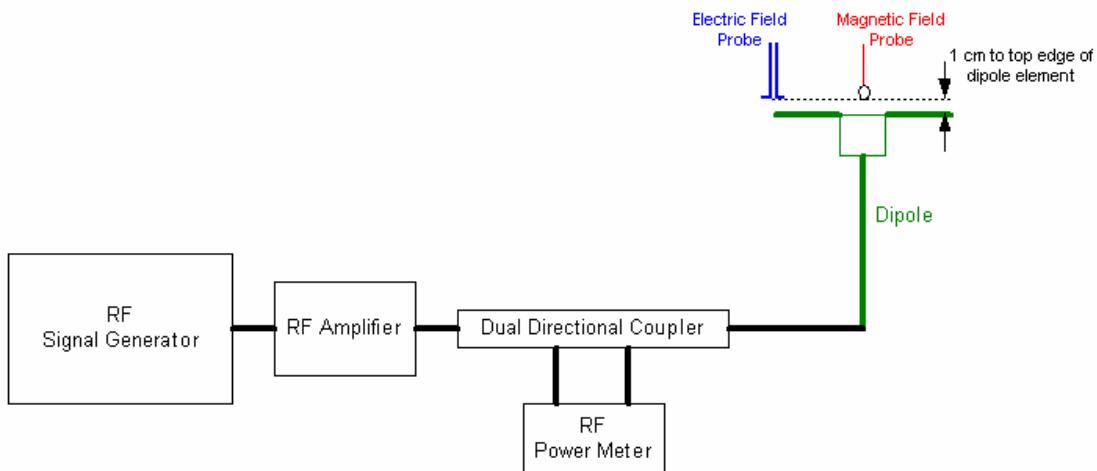
### Validation Procedure

Place a dipole antenna meeting the requirements given in ANSI C63.19 D.5 in the position normally occupied by the WD. The dipole antenna serves as a known source for an electrical and magnetic output. Position the E-field and H-field probes so that:

The probes and their cables are parallel to the coaxial feed of the dipole antenna.

The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions.

The center point of the probe element(s) are 10 mm from the closest surface of the dipole elements. Validation was performed to verify that measured E-field and H-field values are within +/-25% from the target reference values provided by the manufacturer. "Values within +/-25% are acceptable. Of which 12% is deviation and 13% is measurement uncertainty."



**Figure 6 Dipole Validation Setup**

### Dipole Measurement Summary

| E-Field Scan |                 |                  |                                  |                                |                            |               |
|--------------|-----------------|------------------|----------------------------------|--------------------------------|----------------------------|---------------|
| Mode         | Frequency (MHz) | Input Power (mW) | Measured <sup>1</sup> Value(V/m) | Target <sup>2</sup> Value(V/m) | Deviation <sup>3</sup> (%) | Test Date     |
| CW           | 835             | 100              | 149.2                            | 170.7                          | 12.60                      | April 3, 2011 |
| CW           | 1880            | 100              | 131.4                            | 142.9                          | 8.05                       | April 3, 2011 |
| H-Field Scan |                 |                  |                                  |                                |                            |               |
| Mode         | Frequency (MHz) | Input Power (mW) | Measured Value(A/m)              | Target Value(A/m)              | Deviation (%)              | Test Date     |
| CW           | 835             | 100              | 0.443                            | 0.465                          | 4.73                       | April 2, 2011 |
| CW           | 1880            | 100              | 0.449                            | 0.475                          | 5.47                       | April 3, 2011 |

Notes: 1. please refer to the attachment for detailed measurement data and plot.

2. Target value is provided by SPEAD in the calibration certificate of specific dipoles.

3. Deviation (%) = 100 \* (Target value minus Measured value) divided by Target value.

## 2.5. Probe Modulation Factor

The Probe Modulation Factor (PMF) is defined as the ratio of the field readings for a CW and a modulated signal with the equivalent Field Envelope Peak as defined in ANSI C63.19 (Chapter C.3.1). Calibration shall be made of the modulation response of the probe and its instrumentation chain. This Calibration shall be performed with the field probe, attached to the instrumentation that is to be used with it during the measurement. The response of the probe system to a CW field at the frequency(s) of interest is compared to its response to a modulated signal with equal peak amplitude. The field level of the test signals shall be more than 10dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated field shall be applied to the readings taken of modulated fields of the specified type.

### Modulation Factor Test Procedure

This may be done using the following procedure:

1. Fix the field probe in a set location relative to a field generating device, such as the reference dipole antenna.
2. Illuminate the probe using the wireless device connected to the reference dipole with a test signal at the intended measurement frequency. Ensure there is sufficient field coupling between the probe and the antenna so the resulting reading is greater than 10 dB above the probe system noise floor but within the systems operating range.
3. Record the amplitude applied to the antenna during transmission and the field strength measured by the E-field probe located near the tip of the dipole antenna
4. Replace the wireless device with an RF signal generator producing an unmodulated CW signal and set to the wireless device operating frequency.
5. Set the amplitude of the unmodulated signal to equal that recorded from the wireless device.
6. Record the reading of the probe measurement system of the unmodulated signal.
7. The ratio, in linear units, of the probe reading in Step 6 to the reading in Step 3 is the E-field modulation factor.  $PMF_E = E_{CW} / E_{mod}$  ( $PMF_H = H_{CW} / H_{mod}$ )
8. Repeat the previous steps using the H-field probe, except locate the probe at the center of the dipole.

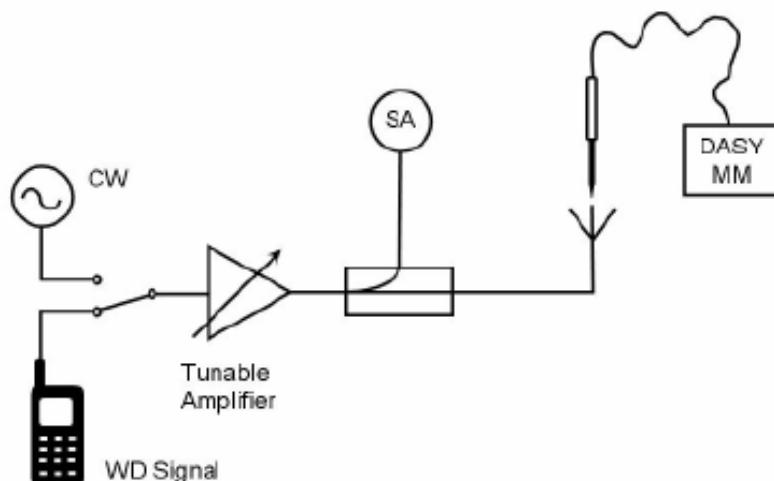


Figure 7 Probe Modulation Factor Test Setup

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**PMF**

| <b>Band</b>   | <b>E-Field Probe Modulation Factor</b> | <b>H-Field Probe Modulation Factor</b> |
|---------------|--|--|
| CDMA Cellular | 1.03                                   | 1.00                                   |
| CDMA PCS      | 1.03                                   | 1.00                                   |
| CDMA AWS      | 1.03                                   | 1.00                                   |

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### 2.6. Conducted Output Power Measurement

#### Summary

The DUT is tested using an E5515C communications tester as controller unit to set test channels and maximum output power to the DUT, as well as for measuring the conducted power. Conducted output power was measured using an integrated RF connector and attached RF cable. This result contains conducted output power for the EUT.

#### Conducted Power Results

| CDMA Cellular |             | Conducted Power (dBm) |             |              |
|---------------|-------------|-----------------------|-------------|--------------|
|               |             | Channel 1013          | Channel 384 | Channel 777  |
| RC3           | Before test | 24.3                  | 24.3        | 24.4         |
|               | After test  | 24.4                  | 24.3        | 24.3         |
| RC1           | Before test | 24.4                  | 24.2        | 24.3         |
| CDMA PCS      |             | Conducted Power (dBm) |             |              |
|               |             | Channel 25            | Channel 600 | Channel 1175 |
| RC3           | Before test | 24.3                  | 24.3        | 24.4         |
|               | After test  | 24.4                  | 24.4        | 24.5         |
| RC1           | Before test | 24.3                  | 24.3        | 24.2         |
| CDMA AWS      |             | Conducted Power (dBm) |             |              |
|               |             | Channel 25            | Channel 450 | Channel 850  |
| RC3           | Before test | 24.4                  | 24.5        | 24.2         |
|               | After test  | 24.4                  | 24.4        | 24.4         |
| RC1           | Before test | 24.4                  | 24.4        | 24.5         |

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### 3. Test Results

#### 3.1. ANSI C63.19-2007 Limits

| Category       |     | Telephone RF parameters < 960 MHz |     |                   |     |
|----------------|-----|-----------------------------------|-----|-------------------|-----|
| Near field     | AWF | E-field emissions                 |     | H-field emissions |     |
| Category M1/T1 | 0   | 631.0 to 1122.0                   | V/m | 1.91 to 3.39      | A/m |
|                | -5  | 473.2 to 841.4                    | V/m | 1.43 to 2.54      | A/m |
| Category M2/T2 | 0   | 354.8 to 631.0                    | V/m | 1.07 to 1.91      | A/m |
|                | -5  | 266.1 to 473.2                    | V/m | 0.80 to 1.43      | A/m |
| Category M3/T3 | 0   | 199.5 to 354.8                    | V/m | 0.60 to 1.07      | A/m |
|                | -5  | 149.6 to 266.1                    | V/m | 0.45 to 0.80      | A/m |
| Category M4/T4 | 0   | < 199.5                           | V/m | < 0.60            | A/m |
|                | -5  | < 149.6                           | V/m | < 0.45            | A/m |
| Category       |     | Telephone RF parameters > 960 MHz |     |                   |     |
| Near field     | AWF | E-field emissions                 |     | H-field emissions |     |
| Category M1/T1 | 0   | 199.5 to 354.8                    | V/m | 0.60 to 1.07      | A/m |
|                | -5  | 149.6 to 266.1                    | V/m | 0.45 to 0.80      | A/m |
| Category M2/T2 | 0   | 112.2 to 199.5                    | V/m | 0.34 to 0.60      | A/m |
|                | -5  | 84.1 to 149.6                     | V/m | 0.25 to 0.45      | A/m |
| Category M3/T3 | 0   | 63.1 to 112.2                     | V/m | 0.19 to 0.34      | A/m |
|                | -5  | 47.3 to 84.1                      | V/m | 0.14 to 0.25      | A/m |
| Category M4/T4 | 0   | < 63.1                            | V/m | < 0.19            | A/m |
|                | -5  | < 47.3                            | V/m | < 0.14            | A/m |

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### 3.2. Summary Test Results

#### CDMA Cellular Results

| <b>E-Field</b> |                        |                         |                         |               |                      |
|----------------|------------------------|-------------------------|-------------------------|---------------|----------------------|
| <b>Channel</b> | <b>Frequency (MHz)</b> | <b>Peak Field (V/m)</b> | <b>Power Drift (dB)</b> | <b>Rating</b> | <b>Graph Results</b> |
| 777            | 848.31                 | 74.9                    | -0.013                  | M4            | Figure 12            |
| 384            | 836.52                 | 79.1                    | -0.031                  | M4            | Figure 13            |
| 1013           | 824.70                 | 74.1                    | -0.026                  | M4            | Figure 14            |
| <b>H-Field</b> |                        |                         |                         |               |                      |
| <b>Channel</b> | <b>Frequency (MHz)</b> | <b>Peak Field (A/m)</b> | <b>Power Drift (dB)</b> | <b>Rating</b> | <b>Graph Results</b> |
| 777            | 848.31                 | 0.116                   | -0.043                  | M4            | Figure 15            |
| 384            | 836.52                 | 0.12                    | -0.040                  | M4            | Figure 16            |
| 1013           | 824.70                 | 0.11                    | -0.008                  | M4            | Figure 17            |

#### CDMA PCS Results

| <b>E-Field</b> |                        |                         |                         |               |                      |
|----------------|------------------------|-------------------------|-------------------------|---------------|----------------------|
| <b>Channel</b> | <b>Frequency (MHz)</b> | <b>Peak Field (V/m)</b> | <b>Power Drift (dB)</b> | <b>Rating</b> | <b>Graph Results</b> |
| 1175           | 1908.75                | 42.9                    | -0.134                  | M4            | Figure 18            |
| 600            | 1880                   | 42.1                    | -0.040                  | M4            | Figure 19            |
| 25             | 1851.25                | 42.6                    | -0.125                  | M4            | Figure 20            |
| <b>H-Field</b> |                        |                         |                         |               |                      |
| <b>Channel</b> | <b>Frequency (MHz)</b> | <b>Peak Field (A/m)</b> | <b>Power Drift (dB)</b> | <b>Rating</b> | <b>Graph Results</b> |
| 1175           | 1908.75                | 0.104                   | -0.034                  | M4            | Figure 21            |
| 600            | 1880                   | 0.097                   | -0.073                  | M4            | Figure 22            |
| 25             | 1851.25                | 0.1                     | -0.060                  | M4            | Figure 23            |

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**CDMA AWS Results**

| <b>E-Field</b> |                        |                         |                         |               |                      |
|----------------|------------------------|-------------------------|-------------------------|---------------|----------------------|
| <b>Channel</b> | <b>Frequency (MHz)</b> | <b>Peak Field (V/m)</b> | <b>Power Drift (dB)</b> | <b>Rating</b> | <b>Graph Results</b> |
| 850            | 1752.5                 | 41.3                    | -0.009                  | M4            | Figure 24            |
| 450            | 1732.5                 | 42.6                    | 0.055                   | M4            | Figure 25            |
| 25             | 1711.25                | 40.9                    | -0.009                  | M4            | Figure 26            |

| <b>H-Field</b> |                        |                         |                         |               |                      |
|----------------|------------------------|-------------------------|-------------------------|---------------|----------------------|
| <b>Channel</b> | <b>Frequency (MHz)</b> | <b>Peak Field (A/m)</b> | <b>Power Drift (dB)</b> | <b>Rating</b> | <b>Graph Results</b> |
| 850            | 1752.5                 | 0.104                   | -0.037                  | M4            | Figure 27            |
| 450            | 1732.5                 | 0.106                   | -0.020                  | M4            | Figure 28            |
| 25             | 1711.25                | 0.105                   | 0.057                   | M4            | Figure 29            |

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#### 4. Measurement Uncertainty

| No.                        | Error source                   | Type | Uncertainty Value (%) | Prob. Dist. | k          | c <sub>i</sub> E | c <sub>i</sub> H | Standard Uncertainty (%) u <sub>i</sub> (%) E | Standard Uncertainty (%) u <sub>i</sub> (%) H | Degree of freedom V <sub>eff</sub> or v <sub>i</sub> |
|----------------------------|--------------------------------|------|-----------------------|-------------|------------|------------------|------------------|---|---|--|
| <b>Measurement System</b>  |                                |      |                       |             |            |                  |                  |   |   |  |
| 1                          | Probe Calibration              | B    | 5.                    | N           | 1          | 1                | 1                | 5.1   | 5.1   | ∞  |
| 2                          | Axial Isotropy                 | B    | 4.7                   | R           | $\sqrt{3}$ | 1                | 1                | 2.7   | 2.7   | ∞  |
| 3                          | Sensor Displacement            | B    | 16.5                  | R           | $\sqrt{3}$ | 1                | 0.145            | 9.5   | 1.4   | ∞  |
| 4                          | Boundary Effects               | B    | 2.4                   | R           | $\sqrt{3}$ | 1                | 1                | 1.4   | 1.4   | ∞  |
| 5                          | Linearity                      | B    | 4.7                   | R           | $\sqrt{3}$ | 1                | 1                | 2.7   | 2.7   | ∞  |
| 6                          | Scaling to Peak Envelope Power | B    | 2.0                   | R           | $\sqrt{3}$ | 1                | 1                | 1.2   | 1.2   | ∞  |
| 7                          | System Detection Limit         | B    | 1.0                   | R           | $\sqrt{3}$ | 1                | 1                | 0.6   | 0.6   | ∞  |
| 8                          | Readout Electronics            | B    | 0.3                   | N           | 1          | 1                | 1                | 0.3   | 0.3   | ∞  |
| 9                          | Response Time                  | B    | 0.8                   | R           | $\sqrt{3}$ | 1                | 1                | 0.5   | 0.5   | ∞  |
| 10                         | Integration Time               | B    | 2.6                   | R           | $\sqrt{3}$ | 1                | 1                | 1.5   | 1.5   | ∞  |
| 11                         | RF Ambient Conditions          | B    | 3.0                   | R           | $\sqrt{3}$ | 1                | 1                | 1.7   | 1.7   | ∞  |
| 12                         | RF Reflections                 | B    | 12.0                  | R           | $\sqrt{3}$ | 1                | 1                | 6.9   | 6.9   | ∞  |
| 13                         | Probe Positioner               | B    | 1.2                   | R           | $\sqrt{3}$ | 1                | 0.67             | 0.7   | 0.5   | ∞  |
| 14                         | Probe Positioning              | A    | 4.7                   | R           | $\sqrt{3}$ | 1                | 0.67             | 2.7   | 1.8   | ∞  |
| 15                         | Extra. And Interpolation       | B    | 1.0                   | R           | $\sqrt{3}$ | 1                | 1                | 0.6   | 0.6   | ∞  |
| <b>Test Sample Related</b> |                                |      |                       |             |            |                  |                  |   |   |  |
| 16                         | Device Positioning Vertical    | B    | 4.7                   | R           | $\sqrt{3}$ | 1                | 0.67             | 2.7   | 1.8   | ∞  |
| 17                         | Device Positioning Lateral     | B    | 1.0                   | R           | $\sqrt{3}$ | 1                | 1                | 0.6   | 0.6   | ∞  |
| 18                         | Device Holder and Phantom      | B    | 2.4                   | R           | $\sqrt{3}$ | 1                | 1                | 1.4   | 1.4   | ∞  |

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|  |                   |   |              |   |            |     |      |      |      |          |
|--|-------------------|---|--------------|---|------------|-----|------|------|------|----------|
| 19   | Power Drift       | B | 5.0          | R | $\sqrt{3}$ | 1   | 1    | 2.9  | 2.9  | $\infty$ |
| <b>Phantom and Setup related</b>                         |                   |   |              |   |            |     |      |      |      |          |
| 20s  | Phantom Thickness | B | 2.4          | R | $\sqrt{3}$ | 1   | 0.67 | 1.4  | 0.9  | $\infty$ |
| Combined standard uncertainty(%)                         |                   |   |              |   |            |     |      | 14.7 | 10.9 |          |
| Expanded uncertainty<br>(confidence interval of<br>95 %) |                   |   | $u_e = 2u_c$ | N |            | k=2 |      | 29.4 | 21.8 |          |

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## 5. Main Test Instruments

| No. | Name                   | Type           | Serial Number | Calibration Date         | Valid Period |
|-----|------------------------|----------------|---------------|--------------------------|--------------|
| 01  | Power meter            | Agilent E4417A | GB41291714    | March 12, 2011           | One year     |
| 02  | Power sensor           | Agilent N8481H | MY50350004    | September 26, 2010       | One year     |
| 03  | Signal Generator       | HP 8341B       | 2730A00804    | September 13, 2010       | One year     |
| 04  | Amplifier              | IXA-020        | 0401          | No Calibration Requested |              |
| 05  | BTS                    | E5515C         | MY48360988    | December 3, 2010         | One year     |
| 06  | E-Field Probe          | ER3DV6         | 2428          | October 20, 2009         | Two years    |
| 07  | H-Field Probe          | H3DV6          | 6260          | October 20, 2009         | Two years    |
| 08  | DAE                    | DAE4           | 871           | November 18, 2010        | One year     |
| 09  | Validation Kit 835MHz  | CD835V3        | 1149          | January 12, 2010         | Two years    |
| 10  | Validation Kit 1880MHz | CD1880V3       | 1135          | January 13, 2010         | Two years    |

\*\*\*\*\*END OF REPORT BODY\*\*\*\*\*

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## ANNEX A: System Check Results

### HAC\_System Performance Check at 835MHz\_E

**DUT: Dipole 835 MHz; Type: CD835V3; SN:1149**

Date/Time: 4/3/2011 5:13:32 AM

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

**E Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 149.2 V/m

Probe Modulation Factor = 1.00

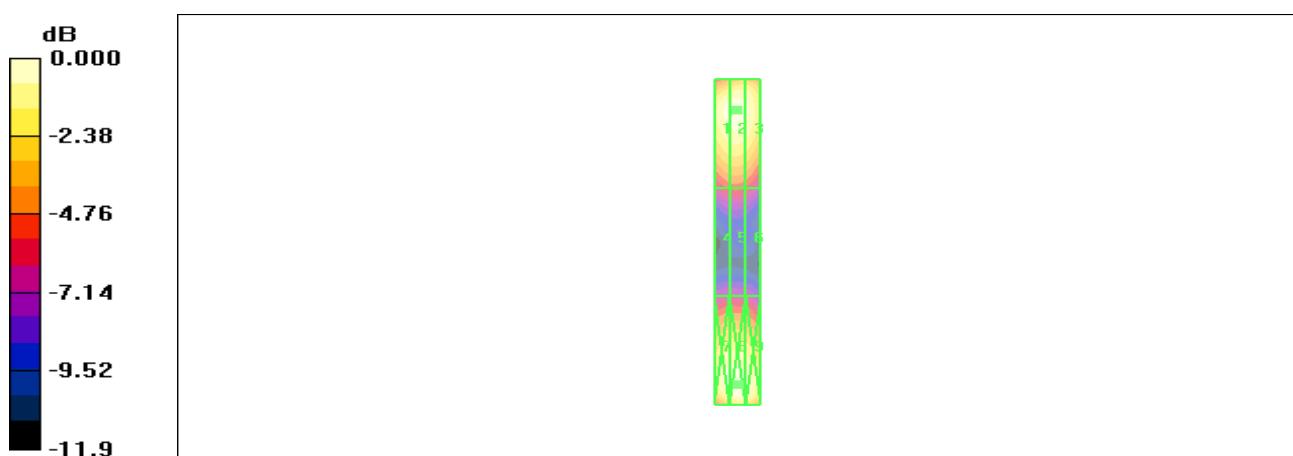
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 100.7 V/m; Power Drift = -0.066 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak E-field in V/m

| Grid 1          | Grid 2          | Grid 3          |
|-----------------|-----------------|-----------------|
| <b>147.0 M4</b> | <b>149.2 M4</b> | <b>143.9 M4</b> |
| Grid 4          | Grid 5          | Grid 6          |
| <b>83.4 M4</b>  | <b>85.0 M4</b>  | <b>81.1 M4</b>  |



0 dB = 154.0V/m

**Figure 8 System Performance Check 835MHz\_E**

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### HAC\_System Performance Check at 835MHz\_H

**DUT: Dipole 835 MHz; Type: CD835V3; SN: 1149**

Date/Time: 4/2/2011 12:04:58 AM

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6260 ; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

**H Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.443 A/m

Probe Modulation Factor = 1.00

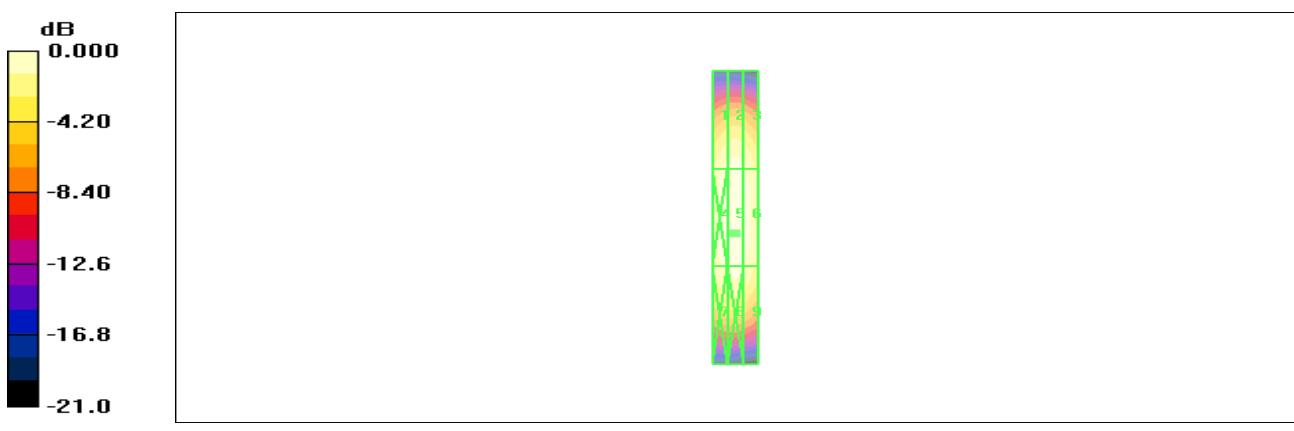
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.464 A/m; Power Drift = 0.019 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak H-field in A/m

| Grid 1          | Grid 2          | Grid 3          |
|-----------------|-----------------|-----------------|
| <b>0.391 M4</b> | <b>0.408 M4</b> | <b>0.384 M4</b> |
| Grid 4          | Grid 5          | Grid 6          |
| <b>0.427 M4</b> | <b>0.443 M4</b> | <b>0.414 M4</b> |
| Grid 7          | Grid 8          | Grid 9          |
| <b>0.397 M4</b> | <b>0.410 M4</b> | <b>0.381 M4</b> |



0 dB = 0.443A/m

**Figure 9 System Performance Check 835MHz\_H**

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### HAC\_System Performance Check at 1880MHz\_E

**DUT: Dipole 1880 MHz; Type: CD1880V3; SN:1135**

Date/Time: 4/3/2011 6:40:34 AM

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

**E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 131.4 V/m

Probe Modulation Factor = 1.00

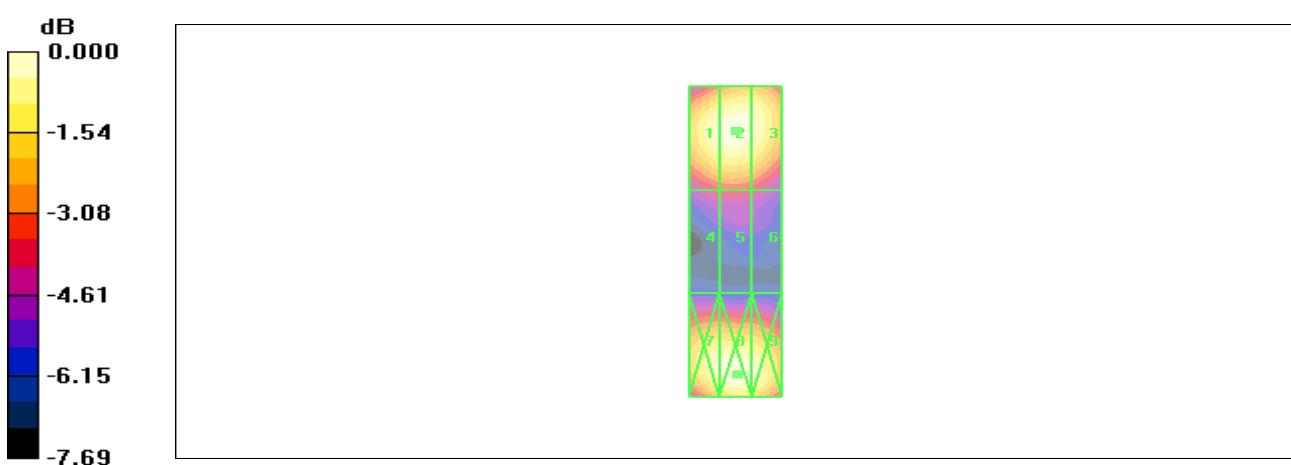
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 151.0 V/m; Power Drift = -0.047 dB

**Hearing Aid Near-Field Category: M2 (AWF 0 dB)**

Peak E-field in V/m

| Grid 1          | Grid 2          | Grid 3          |
|-----------------|-----------------|-----------------|
| <b>128.5 M2</b> | <b>131.4 M2</b> | <b>128.5 M2</b> |
| Grid 4          | <b>89.7 M3</b>  | Grid 6          |
| <b>87.5 M3</b>  |                 | <b>86.2 M3</b>  |
| Grid 7          | Grid 8          | Grid 9          |
| <b>128.7 M2</b> | <b>134.0 M2</b> | <b>130.3 M2</b> |



**Figure 10 System Performance Check 1880MHz\_E**

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## HAC\_System Performance Check at 1880MHz\_H

**DUT: Dipole 1880 MHz; Type: CD1880V3; SN:1135**

Date/Time: 4/3/2011 8:01:22 AM

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6260 ; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

## H Scan - measurement distance from the probe sensor center to Dipole = 10mm/Hearing Aid

**Compatibility Test (41x181x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.449 A/m

Probe Modulation Factor = 1.00

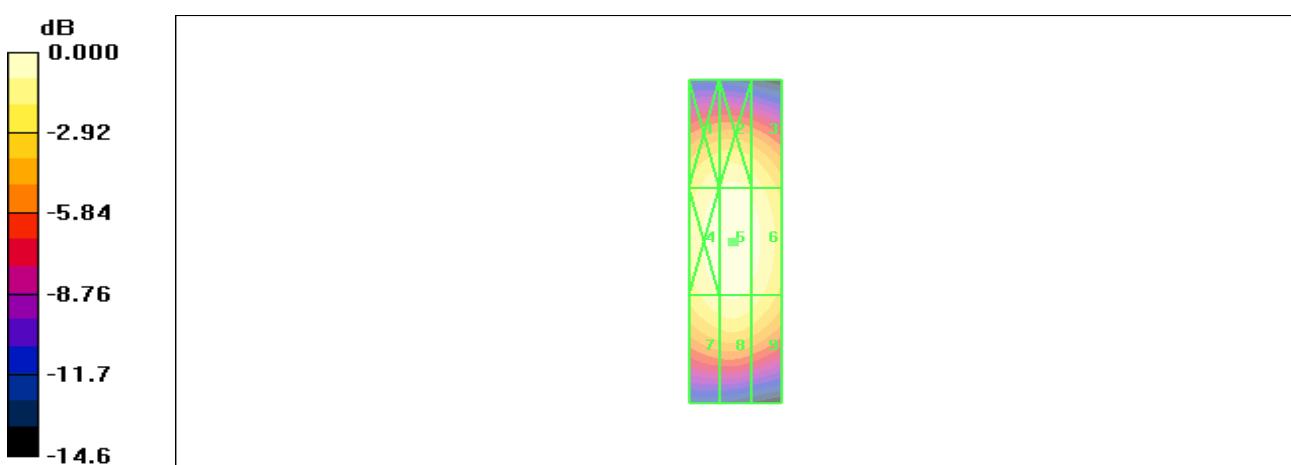
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.472 A/m; Power Drift = -0.005 dB

**Hearing Aid Near-Field Category: M2 (AWF 0 dB)**

Peak H-field in A/m

| Grid 1          | Grid 2          | Grid 3          |
|-----------------|-----------------|-----------------|
| <b>0.400 M2</b> | <b>0.413 M2</b> | <b>0.387 M2</b> |
| Grid 4          | Grid 5          | Grid 6          |
| <b>0.435 M2</b> | <b>0.449 M2</b> | <b>0.422 M2</b> |



**Figure 11 System Performance Check 1880MHz\_H**

## ANNEX B: Graph Results

### HAC RF E-Field CDMA Cellular High

Date/Time: 4/3/2011 10:56:06 AM

Communication System: CDMA Cellular; Frequency: 848.31 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5°C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

### E Scan - ER3D - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility

Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 74.9 V/m

Probe Modulation Factor = 1.03

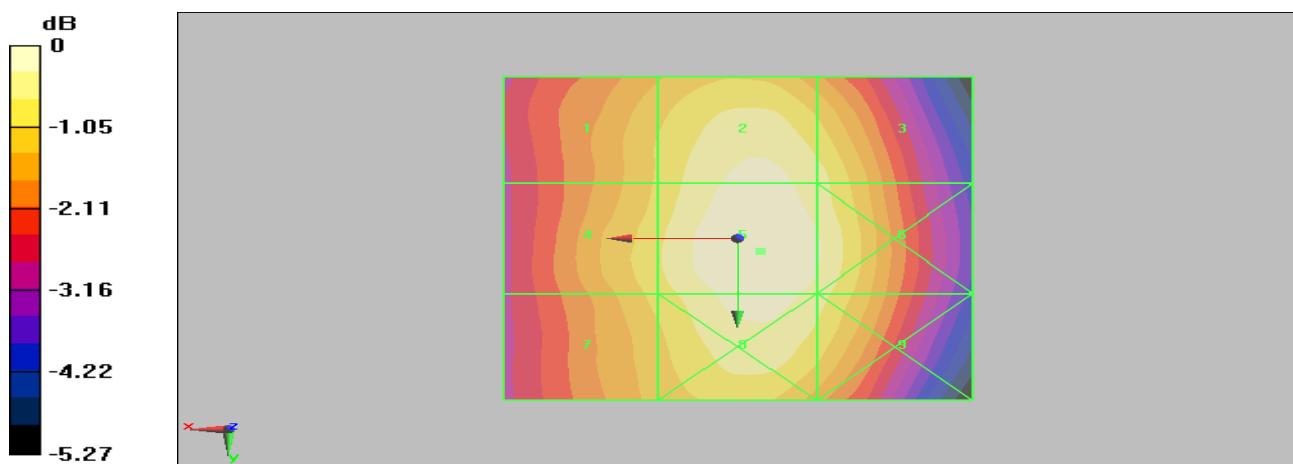
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 94.3 V/m; Power Drift = -0.013 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak E-field in V/m

| Grid 1         | Grid 2         | Grid 3         |
|----------------|----------------|----------------|
| <b>66.8 M4</b> | <b>72.9 M4</b> | <b>70.4 M4</b> |
| <b>68.8 M4</b> | <b>74.9 M4</b> | <b>72.3 M4</b> |
| <b>67.5 M4</b> | <b>73.4 M4</b> | <b>70.6 M4</b> |



**Figure 12 HAC RF E-Field CDMA Cellular Channel 777**

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## HAC RF E-Field CDMA Cellular Middle

Date/Time: 4/3/2011 10:50:37 AM

Communication System: CDMA Cellular; Frequency: 836.52 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

## E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

**Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 79.1 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 100.1 V/m; Power Drift = -0.031 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak E-field in V/m

| Grid 1  | Grid 2  | Grid 3  |
|---------|---------|---------|
| 71.2 M4 | 77.4 M4 | 74.5 M4 |
| Grid 4  | Grid 5  | Grid 6  |
| 73.4 M4 | 79.1 M4 | 76.5 M4 |

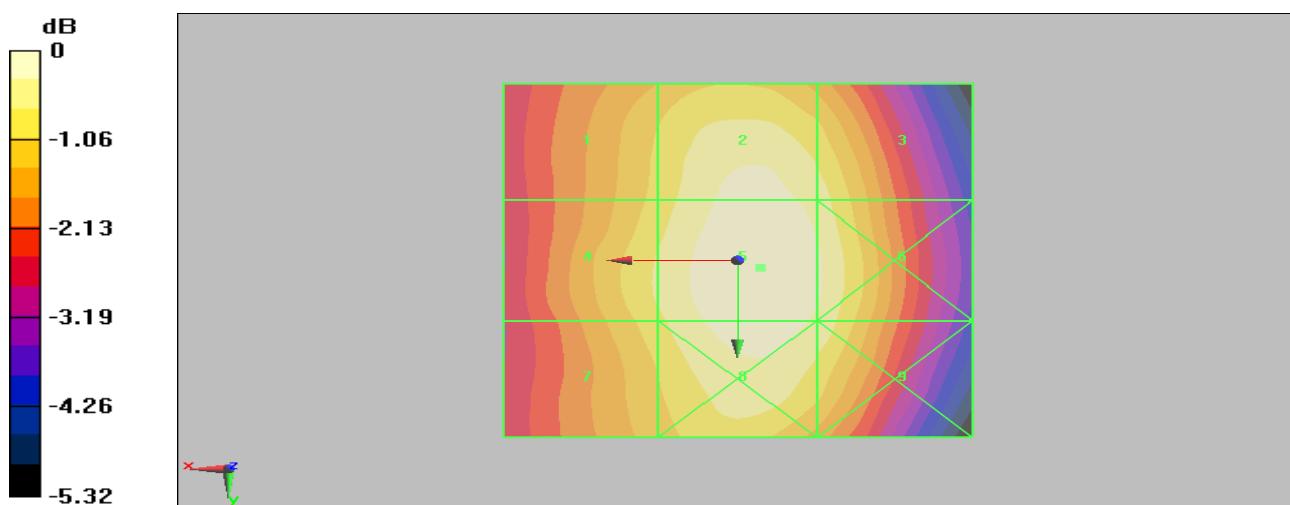


Figure 13 HAC RF E-Field CDMA Cellular Channel 384

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### **HAC RF E-Field CDMA Cellular Low**

Date/Time: 4/3/2011 11:01:29 AM

Communication System: CDMA Cellular; Frequency: 824.7 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

### **E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility**

**Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 74.1 V/m

Probe Modulation Factor = 1.03

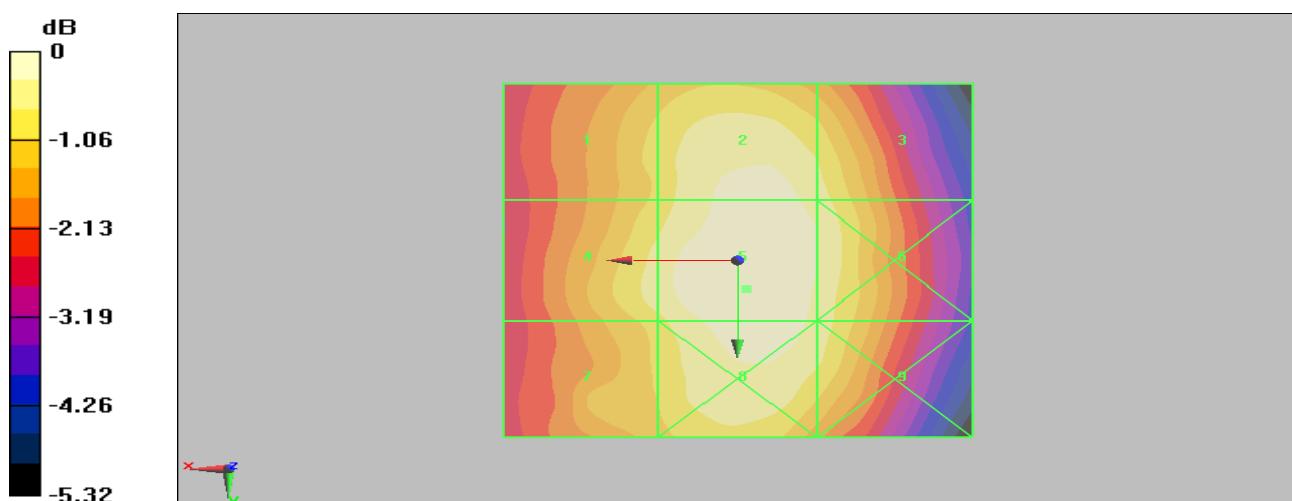
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 93.5 V/m; Power Drift = -0.026 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak E-field in V/m

| Grid 1         | Grid 2         | Grid 3         |
|----------------|----------------|----------------|
| <b>66.9 M4</b> | <b>72.5 M4</b> | <b>69.9 M4</b> |
| Grid 4         | Grid 5         | Grid 6         |
| <b>69.9 M4</b> | <b>74.1 M4</b> | <b>71.3 M4</b> |



0 dB = 74.1V/m

**Figure 14 HAC RF E-Field CDMA Cellular Channel 1013**

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### **HAC RF H-Field CDMA Cellular High**

Date/Time: 4/2/2011 1:29:58 PM

Communication System: CDMA Cellular; Frequency: 848.31 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6260 ; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

### **H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device High/Hearing Aid**

**Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.116 A/m

Probe Modulation Factor = 1

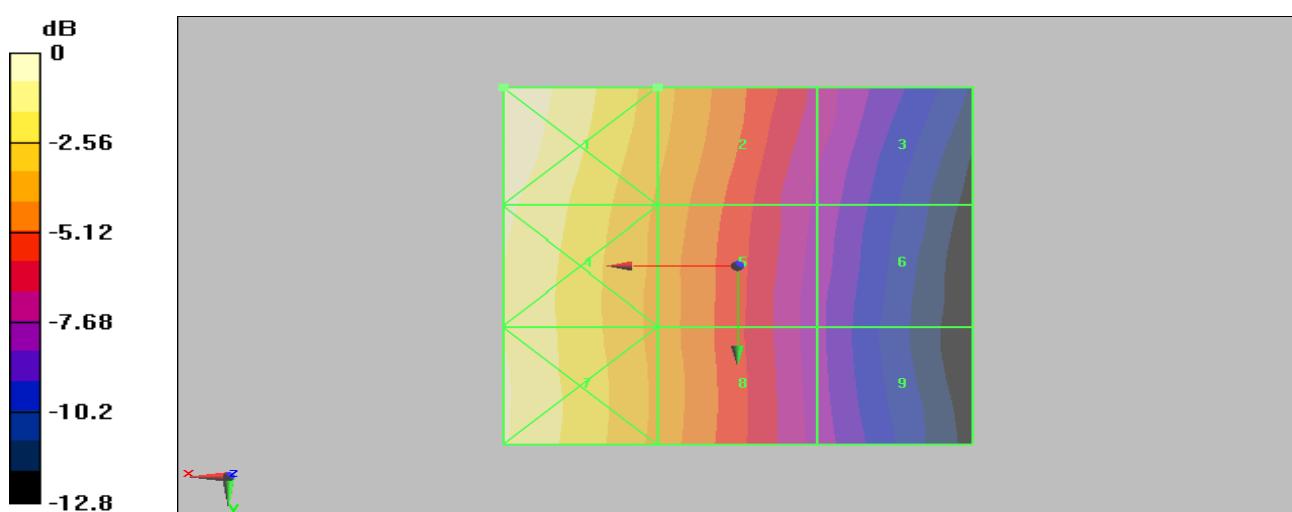
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.086 A/m; Power Drift = -0.043 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak H-field in A/m

| Grid 1          | Grid 2          | Grid 3          |
|-----------------|-----------------|-----------------|
| <b>0.163 M4</b> | <b>0.116 M4</b> | <b>0.072 M4</b> |
| Grid 4          | Grid 5          | Grid 6          |
| <b>0.151 M4</b> | <b>0.109 M4</b> | <b>0.066 M4</b> |



**Figure 15 HAC RF H-Field CDMA Cellular Channel 777**

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## HAC RF H-Field CDMA Cellular Middle

Date/Time: 4/2/2011 1:24:23 PM

Communication System: CDMA Cellular; Frequency: 836.52 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6260 ; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

## H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

**Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.120 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.089 A/m; Power Drift = -0.040 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak H-field in A/m

| Grid 1          | Grid 2          | Grid 3          |
|-----------------|-----------------|-----------------|
| <b>0.172 M4</b> | <b>0.120 M4</b> | <b>0.075 M4</b> |
| Grid 4          | Grid 5          | Grid 6          |
| <b>0.159 M4</b> | <b>0.113 M4</b> | <b>0.068 M4</b> |

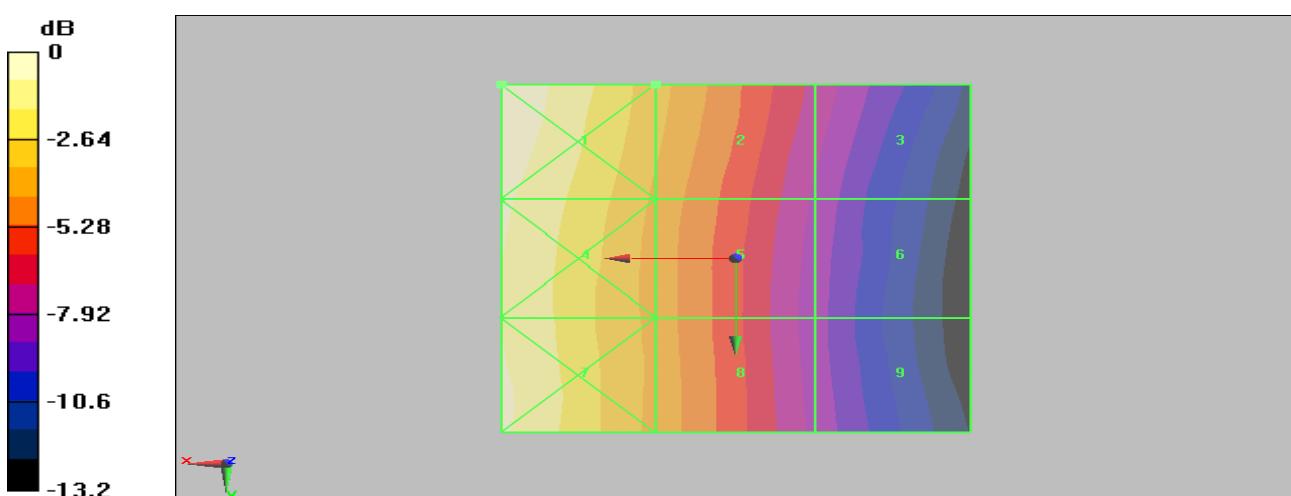


Figure 16 HAC RF H-Field CDMA Cellular Channel 384

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### HAC RF H-Field CDMA Cellular Low

Date/Time: 4/2/2011 1:41:39 PM

Communication System: CDMA Cellular; Frequency: 824.7 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6260 ; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

### H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

**Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.110 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.081 A/m; Power Drift = -0.008 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak H-field in A/m

| Grid 1          | Grid 2          | Grid 3          |
|-----------------|-----------------|-----------------|
| <b>0.156 M4</b> | <b>0.110 M4</b> | <b>0.067 M4</b> |
| Grid 4          | Grid 5          | Grid 6          |
| <b>0.145 M4</b> | <b>0.104 M4</b> | <b>0.061 M4</b> |

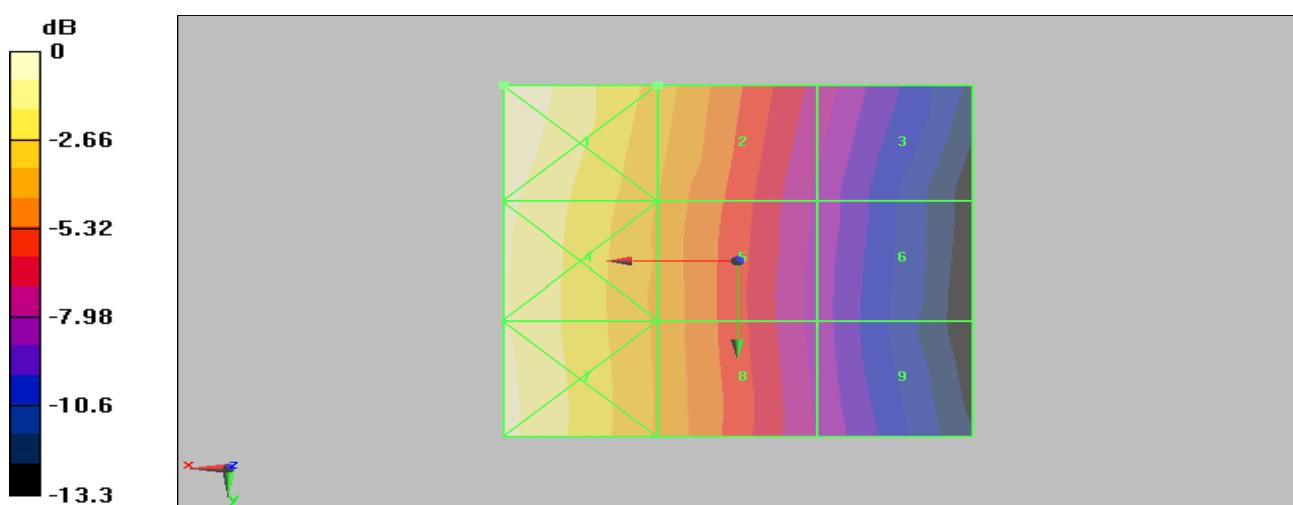


Figure 17 HAC RF H-Field CDMA Cellular Channel 1013

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## HAC RF E-Field CDMA PCS High

Date/Time: 4/3/2011 10:38:13 AM

Communication System: CDMA PCS; Frequency: 1908.75 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

## E Scan - ER3D - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility

**Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 42.9 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 45.6 V/m; Power Drift = -0.134 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak E-field in V/m

| Grid 1  | Grid 2  | Grid 3  |
|---------|---------|---------|
| 27.9 M4 | 33.2 M4 | 33.2 M4 |
| 31.4 M4 | 42.9 M4 | 42.7 M4 |
| 35.6 M4 | 44.1 M4 | 43.5 M4 |

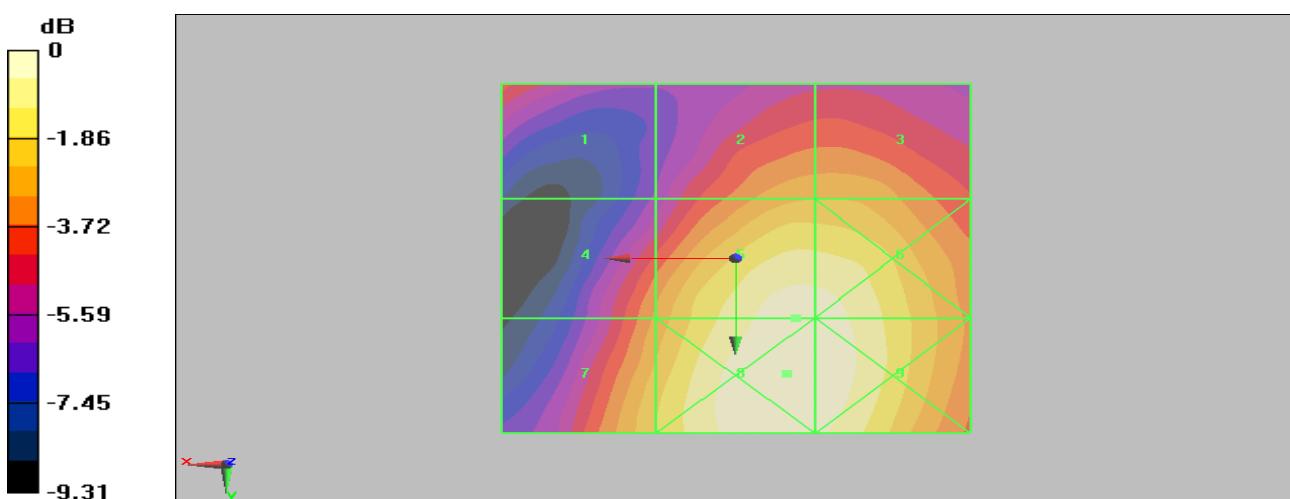


Figure 18 HAC RF E-Field CDMA PCS Channel 1175

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## HAC RF E-Field CDMA PCS Middle

Date/Time: 4/3/2011 10:32:50 AM

Communication System: CDMA PCS; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

## E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

**Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 42.1 V/m

Probe Modulation Factor = 1.03

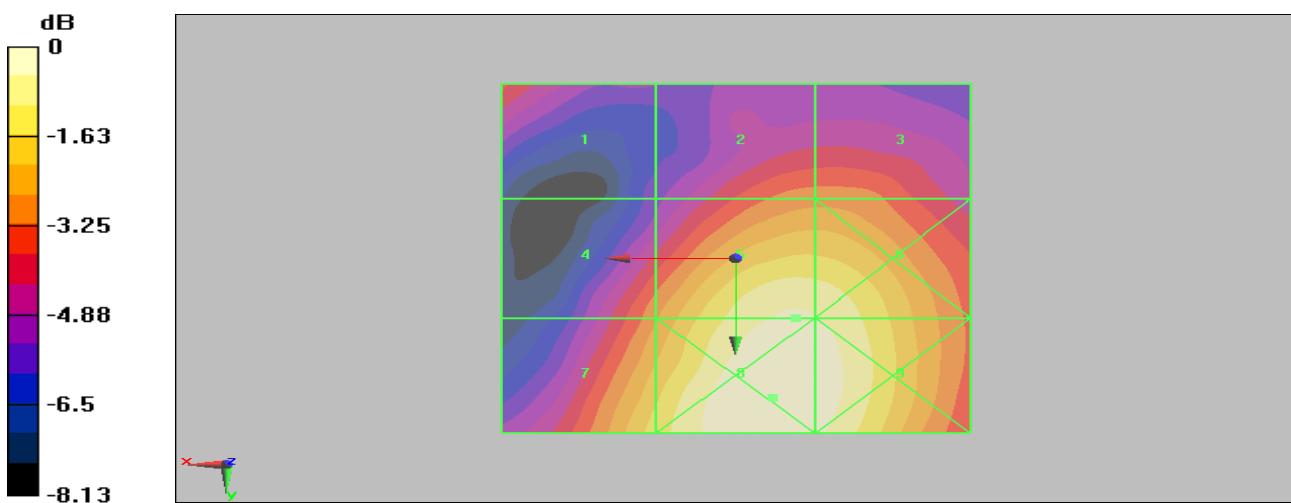
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 43.5 V/m; Power Drift = -0.040 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak E-field in V/m

| Grid 1         | Grid 2         | Grid 3         |
|----------------|----------------|----------------|
| <b>29.5 M4</b> | <b>31.8 M4</b> | <b>31.8 M4</b> |
| Grid 4         | Grid 5         | Grid 6         |
| <b>32.3 M4</b> | <b>42.1 M4</b> | <b>41.8 M4</b> |



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## HAC RF E-Field CDMA PCS Low

Date/Time: 4/3/2011 10:43:41 AM

Communication System: CDMA PCS; Frequency: 1851.25 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

## E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

**Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 42.6 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 44.1 V/m; Power Drift = -0.125 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak E-field in V/m

| Grid 1         | Grid 2         | Grid 3         |
|----------------|----------------|----------------|
| <b>28.6 M4</b> | <b>31.5 M4</b> | <b>31.4 M4</b> |
| Grid 4         | Grid 5         | Grid 6         |
| <b>33.3 M4</b> | <b>42.6 M4</b> | <b>42.1 M4</b> |

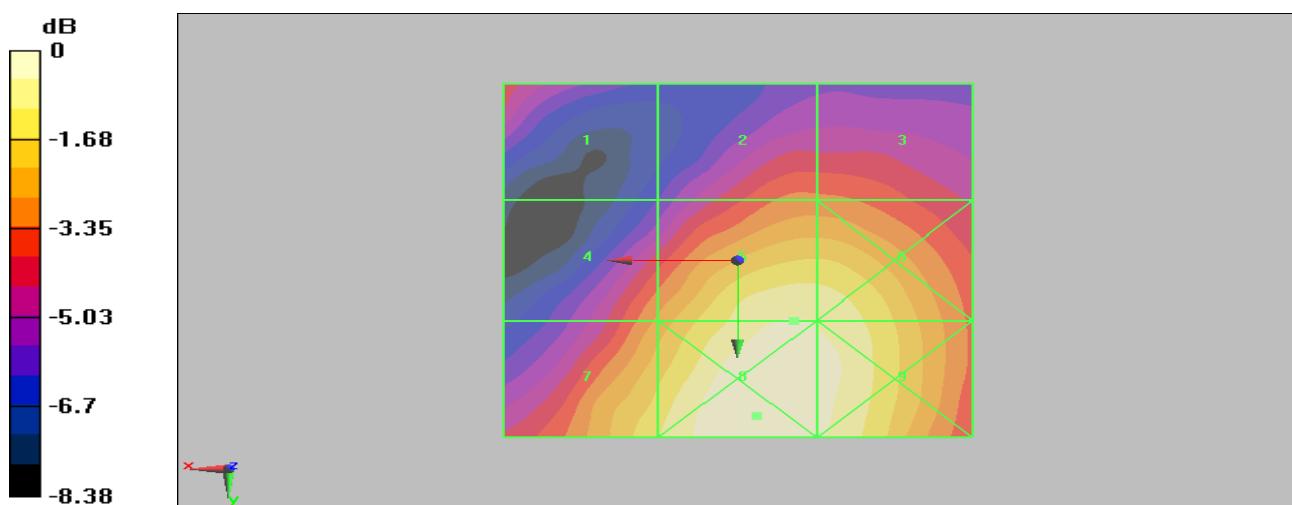


Figure 20 HAC RF E-Field CDMA PCS Channel 25

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**Test Report**

### **HAC RF H-Field CDMA PCS High**

Date/Time: 4/3/2011 9:32:27 AM

Communication System: CDMA PCS; Frequency: 1908.75 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6260 ; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

### **H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device High/Hearing Aid**

**Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.104 A/m

Probe Modulation Factor = 1

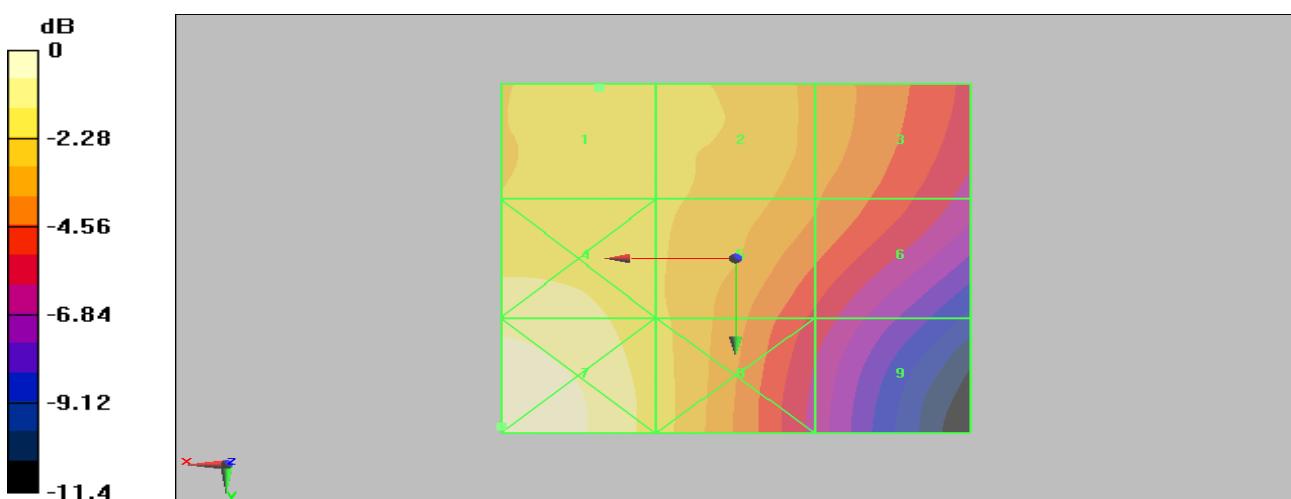
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.098 A/m; Power Drift = -0.034 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak H-field in A/m

| Grid 1          | Grid 2          | Grid 3          |
|-----------------|-----------------|-----------------|
| <b>0.104 M4</b> | <b>0.103 M4</b> | <b>0.090 M4</b> |
| Grid 4          | Grid 5          | Grid 6          |
| <b>0.116 M4</b> | <b>0.102 M4</b> | <b>0.085 M4</b> |



**Figure 21 HAC RF H-Field CDMA PCS Channel 1175**

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## HAC RF H-Field CDMA PCS Middle

Date/Time: 4/3/2011 9:26:42 AM

Communication System: CDMA PCS; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6260 ; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

## H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

**Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.097 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.094 A/m; Power Drift = -0.073 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak H-field in A/m

| Grid 1          | Grid 2          | Grid 3          |
|-----------------|-----------------|-----------------|
| <b>0.097 M4</b> | <b>0.096 M4</b> | <b>0.086 M4</b> |
| Grid 4          | Grid 5          | Grid 6          |
| <b>0.110 M4</b> | <b>0.096 M4</b> | <b>0.083 M4</b> |

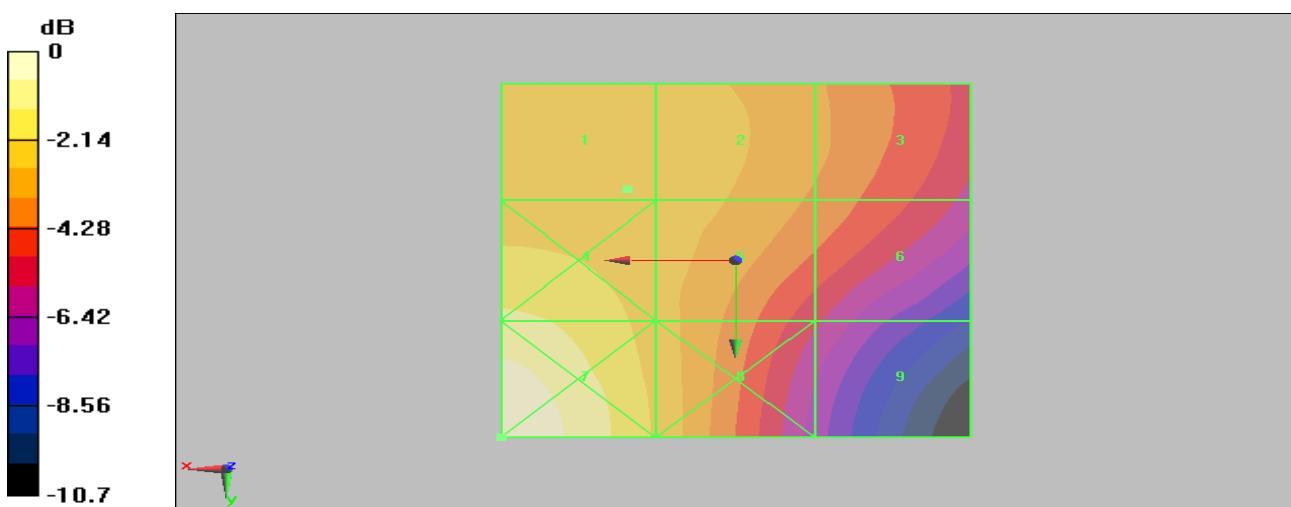


Figure 22 HAC RF H-Field CDMA PCS Channel 600

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## HAC RF H-Field CDMA PCS Low

Date/Time: 4/3/2011 9:37:54 AM

Communication System: CDMA PCS; Frequency: 1851.25 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6260 ; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

## H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

**Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.100 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.098 A/m; Power Drift = -0.060 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak H-field in A/m

| Grid 1          | Grid 2          | Grid 3          |
|-----------------|-----------------|-----------------|
| <b>0.100 M4</b> | <b>0.098 M4</b> | <b>0.087 M4</b> |
| Grid 4          | Grid 5          | Grid 6          |
| <b>0.114 M4</b> | <b>0.099 M4</b> | <b>0.084 M4</b> |

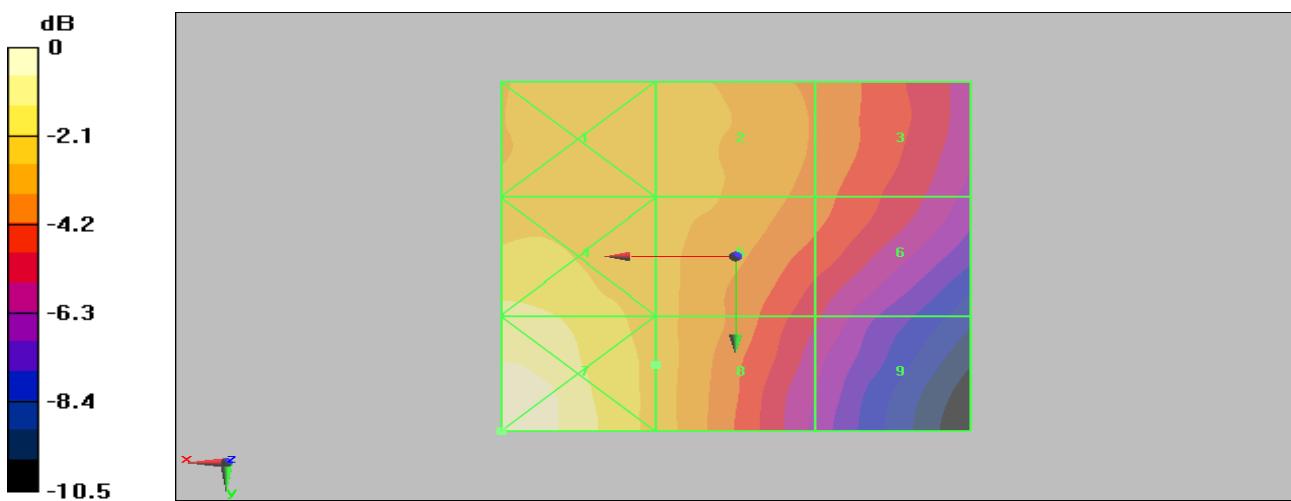


Figure 23 HAC RF H-Field CDMA PCS Channel 25

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### **HAC RF E-Field CDMA AWS High**

Date/Time: 4/3/2011 11:14:27 AM

Communication System: CDMA AWS; Frequency: 1752.5 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

### **E Scan - ER3D - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility**

**Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 41.3 V/m

Probe Modulation Factor = 1.03

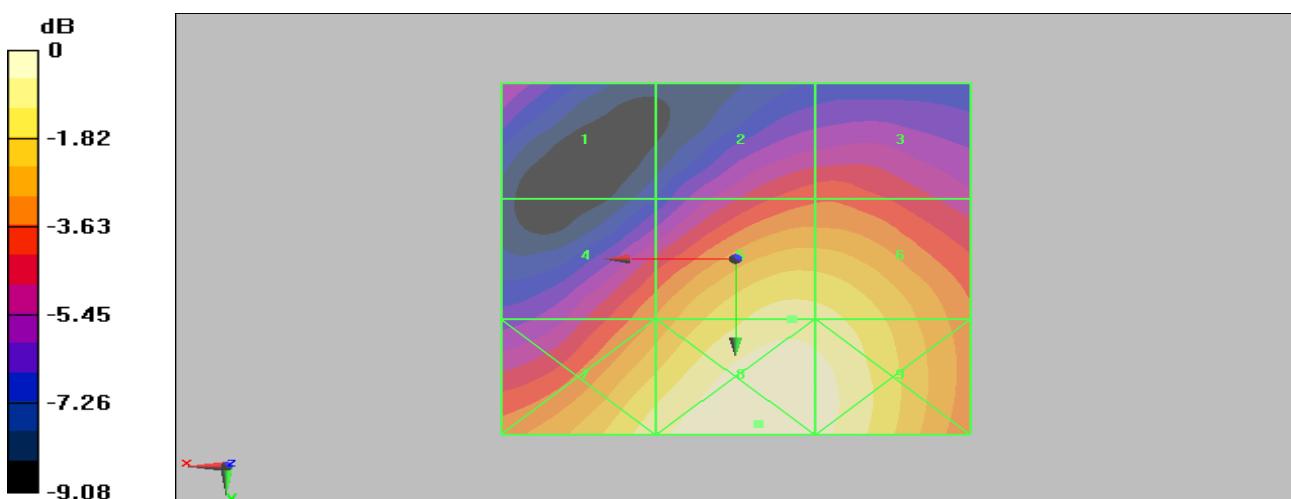
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 40.4 V/m; Power Drift = -0.009 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak E-field in V/m

| Grid 1         | Grid 2         | Grid 3         |
|----------------|----------------|----------------|
| <b>25 M4</b>   | <b>29.9 M4</b> | <b>30 M4</b>   |
| <b>32.6 M4</b> | <b>41.3 M4</b> | <b>41 M4</b>   |
| <b>41.7 M4</b> | <b>45.8 M4</b> | <b>44.3 M4</b> |



**Figure 24 HAC RF E-Field CDMA AWS Channel 850**

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## HAC RF E-Field CDMA AWS Middle

Date/Time: 4/3/2011 11:08:35 AM

Communication System: CDMA AWS; Frequency: 1732.5 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

## E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

**Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 42.6 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 41.8 V/m; Power Drift = 0.055 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak E-field in V/m

| Grid 1  | Grid 2  | Grid 3  |
|---------|---------|---------|
| 23.7 M4 | 31 M4   | 31.1 M4 |
| Grid 4  | Grid 5  | Grid 6  |
| 33.2 M4 | 42.6 M4 | 42.5 M4 |
| Grid 7  | Grid 8  | Grid 9  |
| 42.2 M4 | 47.2 M4 | 45.7 M4 |

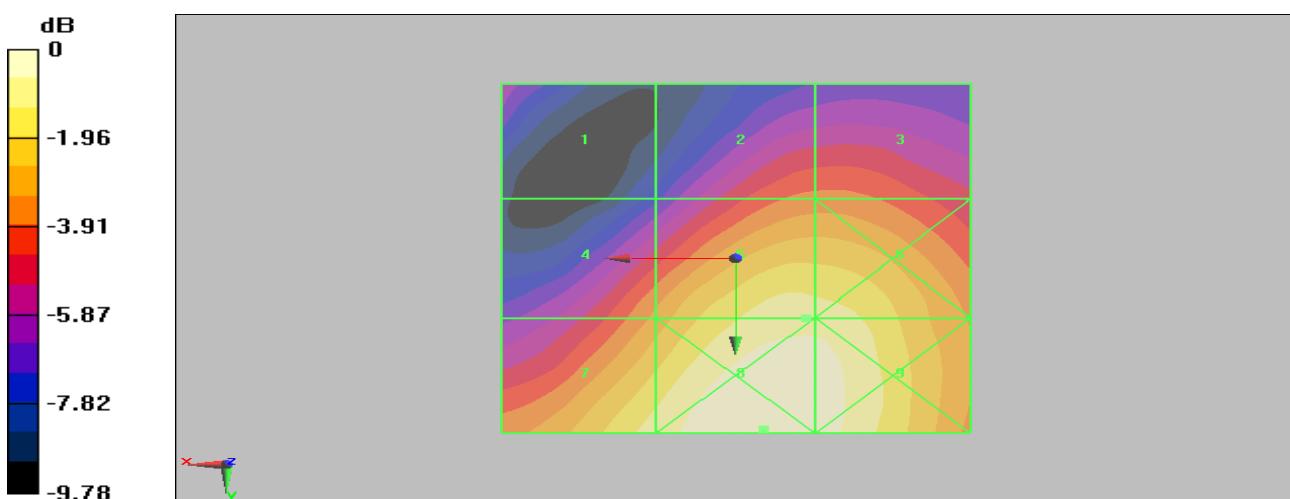


Figure 25 HAC RF E-Field CDMA AWS Channel 450

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## HAC RF E-Field CDMA AWS Low

Date/Time: 4/3/2011 11:19:56 AM

Communication System: CDMA AWS; Frequency: 1711.25 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

## E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

**Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 40.9 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 41 V/m; Power Drift = -0.009 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak E-field in V/m

| Grid 1         | Grid 2         | Grid 3         |
|----------------|----------------|----------------|
| <b>23.3 M4</b> | <b>29.7 M4</b> | <b>29.8 M4</b> |
| Grid 4         | Grid 5         | Grid 6         |
| <b>31.7 M4</b> | <b>40.9 M4</b> | <b>40.8 M4</b> |

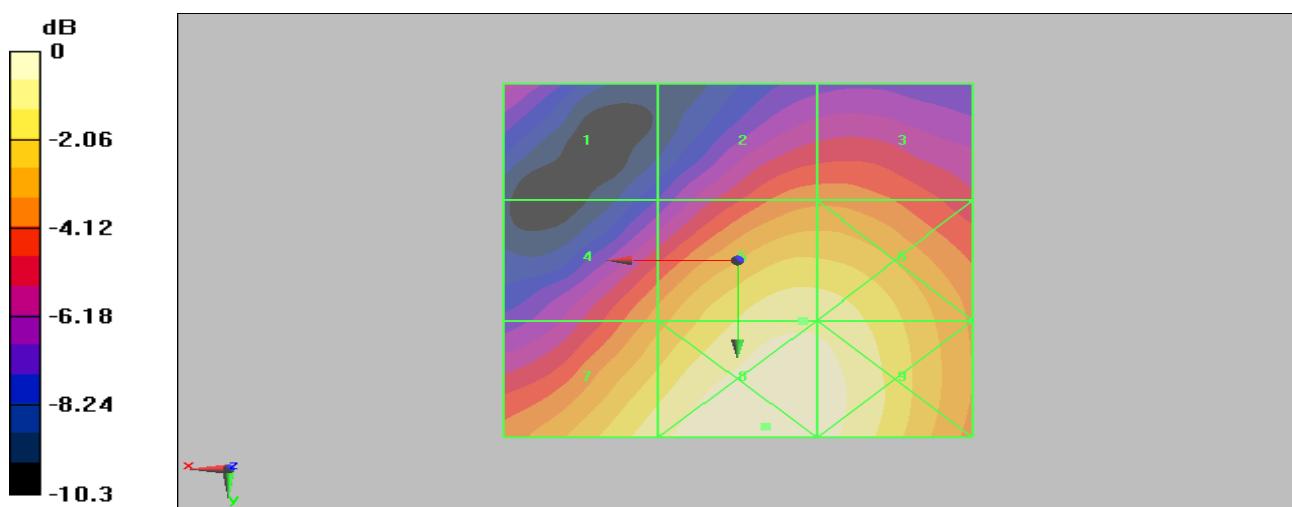


Figure 26 HAC RF E-Field CDMA AWS Channel 25

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## HAC RF H-Field CDMA AWS High

Date/Time: 4/3/2011 9:56:35 AM

Communication System: CDMA AWS; Frequency: 1752.5 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6260 ; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

### H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device High/Hearing Aid

**Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.104 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.101 A/m; Power Drift = -0.037 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak H-field in A/m

| Grid 1          | Grid 2          | Grid 3          |
|-----------------|-----------------|-----------------|
| <b>0.099 M4</b> | <b>0.098 M4</b> | <b>0.083 M4</b> |
| Grid 4          | Grid 5          | Grid 6          |
| <b>0.118 M4</b> | <b>0.104 M4</b> | <b>0.083 M4</b> |
| Grid 7          | Grid 8          | Grid 9          |
| <b>0.135 M4</b> | <b>0.107 M4</b> | <b>0.076 M4</b> |

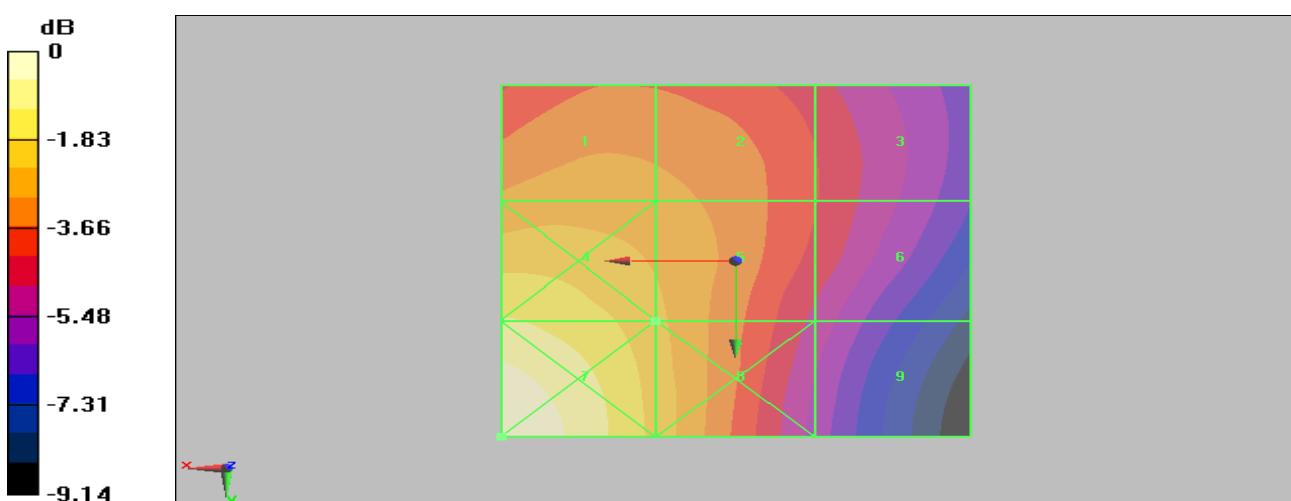


Figure 27 HAC RF H-Field CDMA AWS Channel 850

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## HAC RF H-Field CDMA AWS Middle

Date/Time: 4/3/2011 9:44:43 AM

Communication System: CDMA AWS; Frequency: 1732.5 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6260 ; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

## H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Middle/Hearing Aid

**Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.106 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.102 A/m; Power Drift = -0.020 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak H-field in A/m

| Grid 1          | Grid 2          | Grid 3          |
|-----------------|-----------------|-----------------|
| <b>0.101 M4</b> | <b>0.099 M4</b> | <b>0.083 M4</b> |
| Grid 4          | Grid 5          | Grid 6          |
| <b>0.120 M4</b> | <b>0.106 M4</b> | <b>0.083 M4</b> |

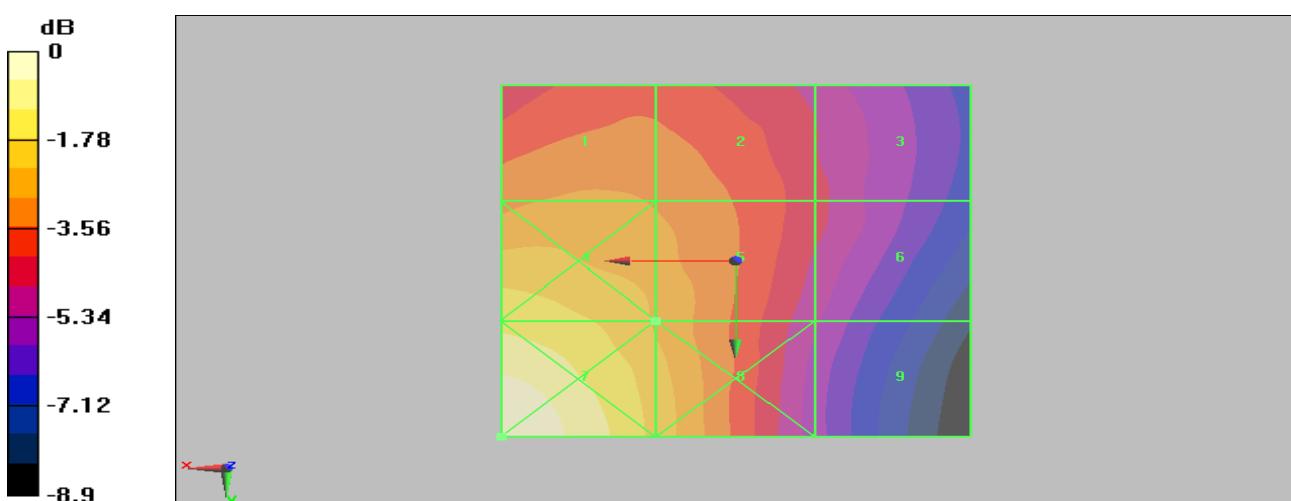


Figure 28 HAC RF H-Field CDMA AWS Channel 450

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## HAC RF H-Field CDMA AWS Low

Date/Time: 4/3/2011 10:01:58 AM

Communication System: CDMA AWS; Frequency: 1711.25 MHz; Duty Cycle: 1:1

Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>

Ambient Temperature: 22.3 °C      Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Probe: H3DV6 - SN6260 ; Calibrated: 10/20/2009

Electronics: DAE4 Sn871; Calibrated: 11/18/2010

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

## H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device Low/Hearing Aid Compatibility

**Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.105 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.100 A/m; Power Drift = 0.057 dB

**Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak H-field in A/m

| Grid 1          | Grid 2          | Grid 3          |
|-----------------|-----------------|-----------------|
| <b>0.103 M4</b> | <b>0.100 M4</b> | <b>0.082 M4</b> |
| Grid 4          | Grid 5          | Grid 6          |
| <b>0.120 M4</b> | <b>0.105 M4</b> | <b>0.082 M4</b> |

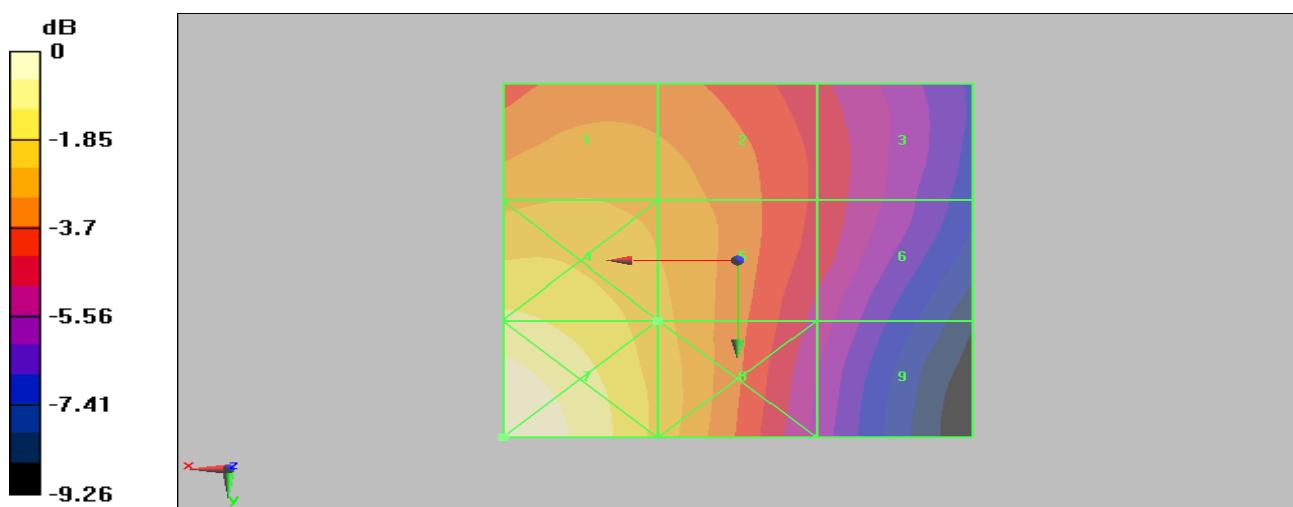


Figure 29 HAC RF H-Field CDMA AWS Channel 25

# TA Technology (Shanghai) Co., Ltd.

## Test Report

Report No. RZA1103-0408HAC01

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### ANNEX C: E-Probe Calibration Certificate

| <p>Calibration Laboratory of<br/>Schmid &amp; Partner<br/>Engineering AG<br/>Zeughausstrasse 43, 8004 Zurich, Switzerland</p> <p> </p> <p>Accredited by the Swiss Accreditation Service (SAS)<br/>The Swiss Accreditation Service is one of the signatories to the EA<br/>Multilateral Agreement for the recognition of calibration certificates</p>  |   | <p>S Schweizerischer Kalibrierdienst<br/>C Service suisse d'étalonnage<br/>S Servizio svizzero di taratura<br/>S Swiss Calibration Service</p> |  |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
|---|---|--|--|----------------------------|--------------------------|---|-------------------|--------------------------|--|---------------------|-------------------|--------------------------|----------------------------|-----------------------|--------------------|--------------------------|--------------------------|---------------------------|---------------------|---------------------------|--------------------------|----------------------------|---------------------|---------------------------|--------------------------|----------------------------|---------------------------|---------------------------|---------------------------|------------------------|----------------------------|-------------------------------|---------------------------|--------|----------------------------|--------------------------------|---------------------------|---------------------|------------------------|-----------------------|-------------------------------|-----------------------|--------------|----------------------------------|--------------------------------|---------------------------|---------------------|-----------------------------------|------------------------|-----------------|-----------------------|-----------------------------------|--|------------------------|---------------------------|-------------------|---|------------------------|----------------|---------------------|-----------------------------------|--|--------------|---------------|-------------------|---|
| Client  | TMC   | Accreditation No.: SCS 108   |  |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
| <p><b>CALIBRATION CERTIFICATE</b></p> <table border="1"><tr><td>Object</td><td>ER3DV6 - SN:2428</td></tr><tr><td>Calibration procedure(s)</td><td>QA CAL-02,v5 and QA CAL-25,v2<br/>Calibration procedure for E-field probes optimized for close near field evaluations in air</td></tr><tr><td>Calibration date:</td><td>October 20, 2009</td></tr><tr><td colspan="2"><p>This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.</p><p>All calibrations have been conducted in the closed laboratory facility: environment temperature <math>(22 \pm 3)^\circ\text{C}</math> and humidity <math>&lt; 70\%</math>.</p><p>Calibration Equipment used (M&amp;TE critical for calibration):</p><table border="1"><thead><tr><th>Primary Standards</th><th>ID #</th><th>Cal Date (Certificate No.)</th><th>Scheduled Calibration</th></tr></thead><tbody><tr><td>Power meter E4419B</td><td>GB41293874</td><td>1-Apr-09 (No. 217-01030)</td><td>Apr-10</td></tr><tr><td>Power sensor E4412A</td><td>MY41495277</td><td>1-Apr-09 (No. 217-01030)</td><td>Apr-10</td></tr><tr><td>Power sensor E4412A</td><td>MY41498087</td><td>1-Apr-09 (No. 217-01030)</td><td>Apr-10</td></tr><tr><td>Reference 3 dB Attenuator</td><td>SN: S5054 (3c)</td><td>31-Mar-09 (No. 217-01026)</td><td>Mar-10</td></tr><tr><td>Reference 20 dB Attenuator</td><td>SN: S5086 (20b)</td><td>31-Mar-09 (No. 217-01028)</td><td>Mar-10</td></tr><tr><td>Reference 30 dB Attenuator</td><td>SN: S5129 (30b)</td><td>31-Mar-09 (No. 217-01027)</td><td>Mar-10</td></tr><tr><td>Reference Probe ER3DV6</td><td>SN: 2328</td><td>3-Oct-09 (No. ER3-2328_Oct09)</td><td>Oct-10</td></tr><tr><td>DAE4</td><td>SN: 789</td><td>19-Dec-08 (No. DAE4-789_Dec08)</td><td>Dec-09</td></tr><tr><td>Secondary Standards</td><td>ID #</td><td>Check Date (in house)</td><td>Scheduled Check</td></tr><tr><td>RF generator HP 8648C</td><td>US3642U01700</td><td>4-Aug-09 (in house check Oct-09)</td><td>In house check: Oct-11</td></tr><tr><td>Network Analyzer HP 8753E</td><td>US37390585</td><td>18-Oct-01 (in house check Oct-09)</td><td>In house check: Oct-10</td></tr><tr><td>Calibrated by:</td><td>Name<br/>Marcel Fehr</td><td>Function<br/>Laboratory Technician</td><td>Signature<br/></td></tr><tr><td>Approved by:</td><td>Katja Pokovic</td><td>Technical Manager</td><td></td></tr></tbody></table><p>This calibration certificate shall not be reproduced except in full without written approval of the laboratory.</p><p>Issued: October 22, 2009</p></td></tr></table> |   |  | Object   | ER3DV6 - SN:2428           | Calibration procedure(s) | QA CAL-02,v5 and QA CAL-25,v2<br>Calibration procedure for E-field probes optimized for close near field evaluations in air | Calibration date: | October 20, 2009         | <p>This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). 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| Object  | ER3DV6 - SN:2428  |  |  |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
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| Primary Standards   | ID #  | Cal Date (Certificate No.)   | Scheduled Calibration  |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
| Power meter E4419B  | GB41293874  | 1-Apr-09 (No. 217-01030)   | Apr-10   |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
| Power sensor E4412A   | MY41495277  | 1-Apr-09 (No. 217-01030)   | Apr-10   |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
| Power sensor E4412A   | MY41498087  | 1-Apr-09 (No. 217-01030)   | Apr-10   |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
| Reference 3 dB Attenuator   | SN: S5054 (3c)  | 31-Mar-09 (No. 217-01026)  | Mar-10   |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
| Reference 20 dB Attenuator  | SN: S5086 (20b)   | 31-Mar-09 (No. 217-01028)  | Mar-10   |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
| Reference 30 dB Attenuator  | SN: S5129 (30b)   | 31-Mar-09 (No. 217-01027)  | Mar-10   |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
| Reference Probe ER3DV6  | SN: 2328  | 3-Oct-09 (No. ER3-2328_Oct09)  | Oct-10   |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
| DAE4  | SN: 789   | 19-Dec-08 (No. DAE4-789_Dec08)   | Dec-09   |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
| Secondary Standards   | ID #  | Check Date (in house)  | Scheduled Check  |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
| RF generator HP 8648C   | US3642U01700  | 4-Aug-09 (in house check Oct-09)   | In house check: Oct-11   |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
| Network Analyzer HP 8753E   | US37390585  | 18-Oct-01 (in house check Oct-09)  | In house check: Oct-10   |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
| Calibrated by:  | Name<br>Marcel Fehr   | Function<br>Laboratory Technician  | Signature<br> |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
| Approved by:  | Katja Pokovic   | Technical Manager  |               |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |
| Certificate No: ER3-2428_Oct09  |   | Page 1 of 10   |  |                            |                          |   |                   |                          |  |                     |                   |                          |                            |                       |                    |                          |                          |                           |                     |                           |                          |                            |                     |                           |                          |                            |                           |                           |                           |                        |                            |                               |                           |        |                            |                                |                           |                     |                        |                       |                               |                       |              |                                  |                                |                           |                     |                                   |                        |                 |                       |                                   |  |                        |                           |                   |   |                        |                |                     |                                   |  |              |               |                   |   |

# TA Technology (Shanghai) Co., Ltd.

## Test Report

Report No. RZA1103-0408HAC01

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Calibration Laboratory of  
Schmid & Partner  
Engineering AG  
Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

### Glossary:

|                          |  |
|--------------------------|--|
| NORM $x,y,z$             | sensitivity in free space  |
| DCP                      | diode compression point  |
| CF                       | crest factor (1/duty_cycle) of the RF signal   |
| A, B, C                  | modulation dependent linearization parameters  |
| Polarization $\varphi$   | $\varphi$ rotation around probe axis   |
| Polarization $\vartheta$ | $\vartheta$ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis |
| Connector Angle          | information used in DASY system to align probe sensor X to the robot coordinate system   |

### Calibration is Performed According to the Following Standards:

- IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

### Methods Applied and Interpretation of Parameters:

- NORM $x,y,z$ : Assessed for E-field polarization  $\vartheta = 0$  for XY sensors and  $\vartheta = 90$  for Z sensor ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide).
- NORM $(f)x,y,z = NORMx,y,z * frequency\_response$  (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- Ax,y,z; Bx,y,z; Cx,y,z are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

**TA Technology (Shanghai) Co., Ltd.**  
**Test Report**

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ER3DV6 SN:2428

October 20, 2009

# Probe ER3DV6

## SN:2428

Manufactured: September 11, 2007  
Last calibrated: December 13, 2007  
Recalibrated: October 20, 2009

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

# TA Technology (Shanghai) Co., Ltd.

## Test Report

Report No. RZA1103-0408HAC01

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ER3DV6 SN:2428

October 20, 2009

### DASY - Parameters of Probe: ER3DV6 SN:2428

#### Basic Calibration Parameters

|                                     | Sensor X | Sensor Y | Sensor Z | Unc (k=2)   |
|-------------------------------------|----------|----------|----------|-------------|
| Norm ( $\mu$ V/(V/m) <sup>2</sup> ) | 1.52     | 1.59     | 1.86     | $\pm$ 10.1% |
| DCP (mV) <sup>A</sup>               | 91.5     | 93.0     | 98.9     |             |

#### Modulation Calibration Parameters

| UID   | Communication System Name | PAR |             | A<br>dB              | B<br>dBuV            | C                    | VR<br>mV          | Unc<br>(k=2) |
|-------|---------------------------|-----|-------------|----------------------|----------------------|----------------------|-------------------|--------------|
| 10000 | CW                        |     | X<br>Y<br>Z | 0.00<br>0.00<br>0.00 | 0.00<br>0.00<br>0.00 | 1.00<br>1.00<br>1.00 | 300<br>300<br>300 | $\pm$ 1.5%   |

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>A</sup> numerical linearization parameter: uncertainty not required

**TA Technology (Shanghai) Co., Ltd.**  
**Test Report**

Report No. RZA1103-0408HAC01

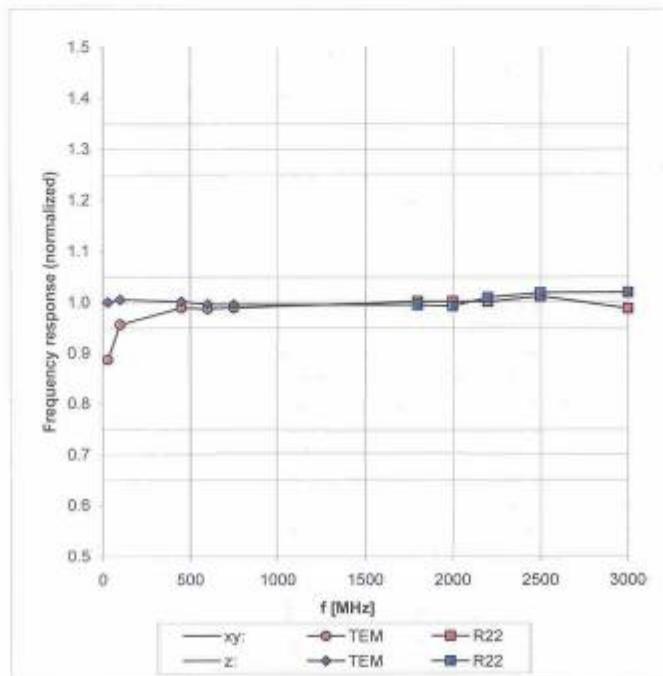
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ER3DV6 SN:2428

October 20, 2009

**Frequency Response of E-Field**

(TEM-Cell:ifi110 EXX, Waveguide R22)



Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  ( $k=2$ )

**TA Technology (Shanghai) Co., Ltd.**  
**Test Report**

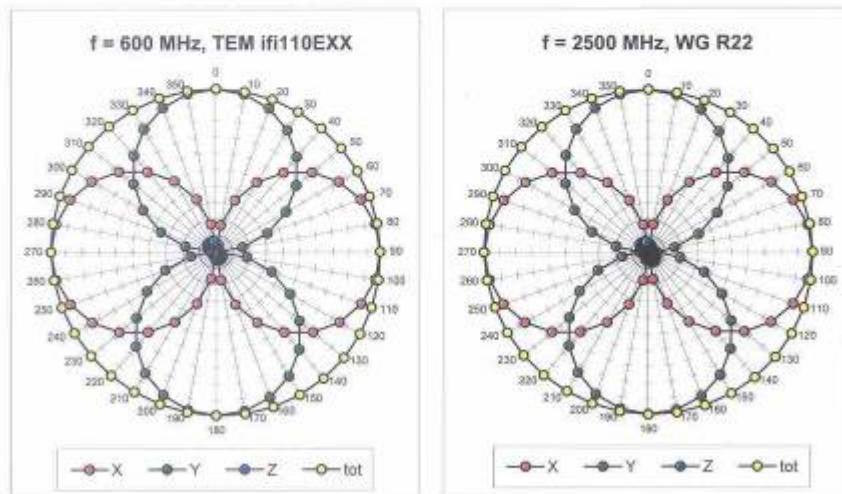
Report No. RZA1103-0408HAC01

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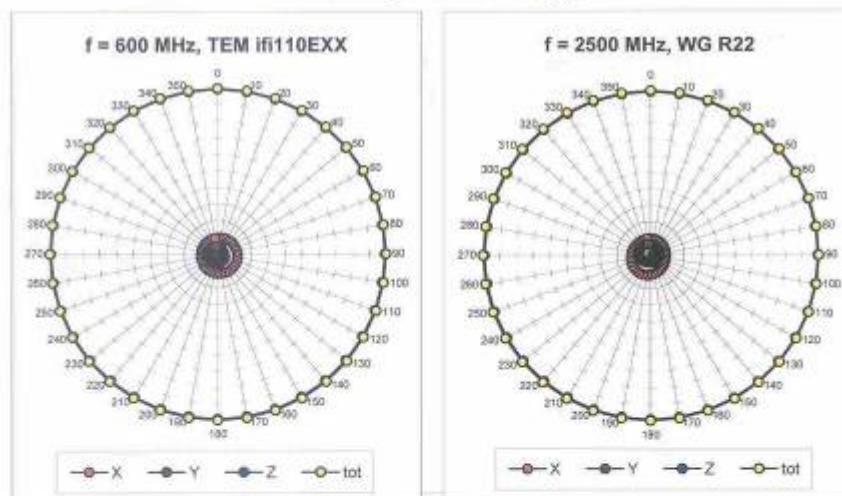
ER3DV6 SN:2428

October 20, 2009

**Receiving Pattern ( $\phi$ ),  $\theta = 0^\circ$**



**Receiving Pattern ( $\phi$ ),  $\theta = 90^\circ$**



**TA Technology (Shanghai) Co., Ltd.**  
**Test Report**

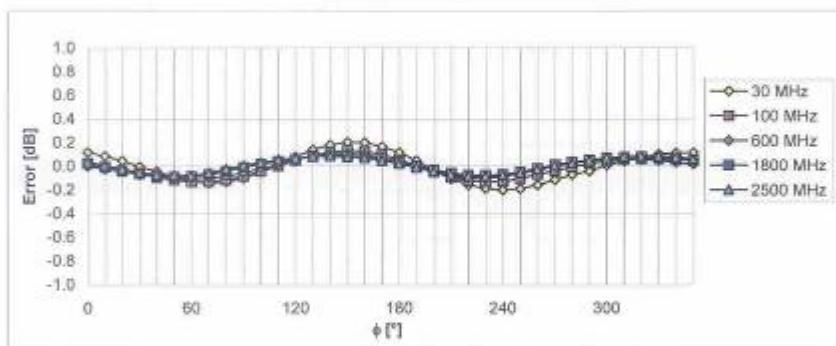
Report No. RZA1103-0408HAC01

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ER3DV6 SN:2428

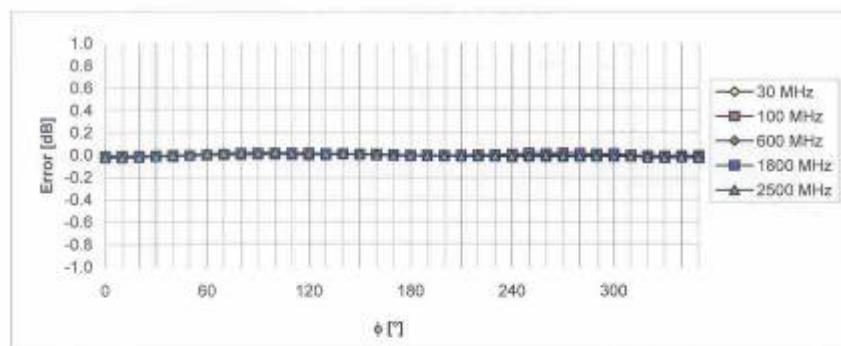
October 20, 2009

**Receiving Pattern ( $\phi$ ),  $\theta = 0^\circ$**



Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )

**Receiving Pattern ( $\phi$ ),  $\theta = 90^\circ$**



Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )

**TA Technology (Shanghai) Co., Ltd.**  
**Test Report**

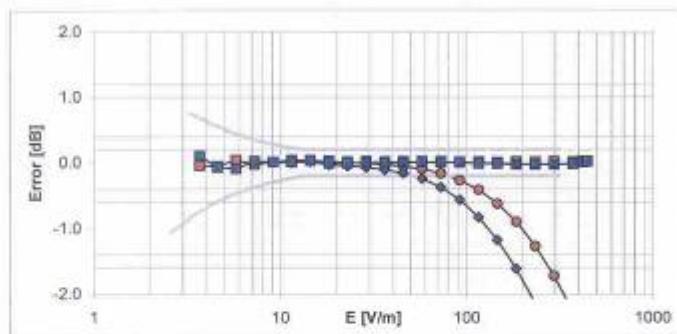
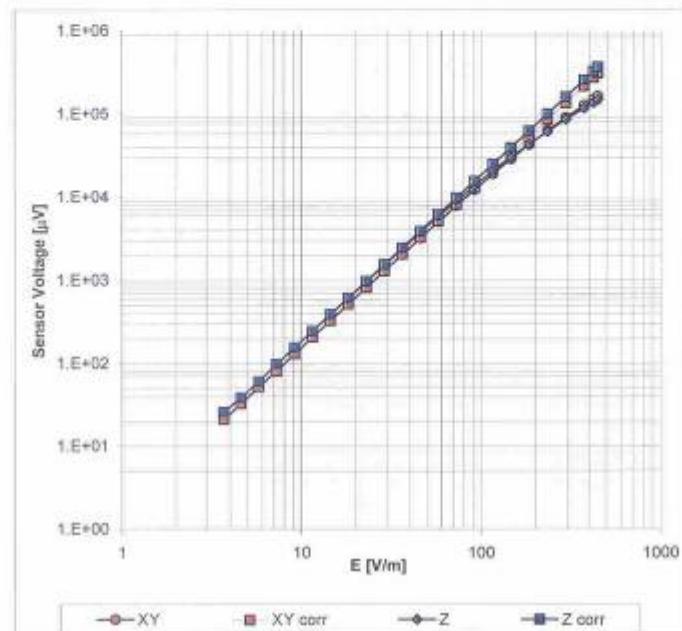
Report No. RZA1103-0408HAC01

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ER3DV6 SN:2428

October 20, 2009

**Dynamic Range f(E-field)**  
(Waveguide R22,  $f = 1800$  MHz)



Uncertainty of Linearity Assessment:  $\pm 0.6\%$  ( $k=2$ )

**TA Technology (Shanghai) Co., Ltd.**  
**Test Report**

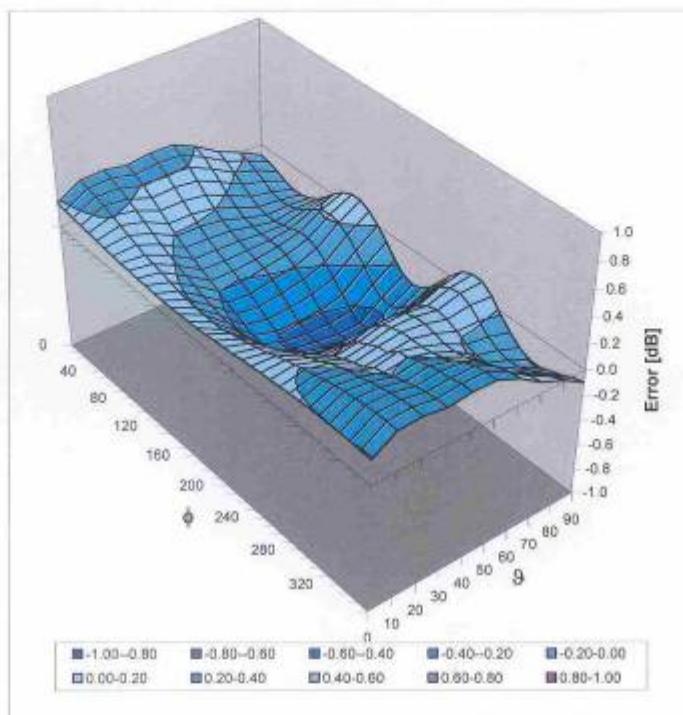
Report No. RZA1103-0408HAC01

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ER3DV6 SN:2428

October 20, 2009

**Deviation from Isotropy in Air**  
**Error ( $\phi, \theta$ ), f = 900 MHz**



Uncertainty of Spherical Isotropy Assessment:  $\pm 2.6\%$  (k=2)

**TA Technology (Shanghai) Co., Ltd.**  
**Test Report**

Report No. RZA1103-0408HAC01

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ER3DV6 SN:2428

October 20, 2009

**Other Probe Parameters**

|   |             |
|---|-------------|
| Sensor Arrangement                      | Rectangular |
| Connector Angle (°)                     | -218.7      |
| Mechanical Surface Detection Mode       | enabled     |
| Optical Surface Detection Mode          | disabled    |
| Probe Overall Length                    | 337 mm      |
| Probe Body Diameter                     | 10 mm       |
| Tip Length                              | 10 mm       |
| Tip Diameter                            | 8.0 mm      |
| Probe Tip to Sensor X Calibration Point | 2.5 mm      |
| Probe Tip to Sensor Y Calibration Point | 2.5 mm      |
| Probe Tip to Sensor Z Calibration Point | 2.5 mm      |

# TA Technology (Shanghai) Co., Ltd.

## Test Report

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### ANNEX D: H-Probe Calibration Certificate

Calibration Laboratory of  
Schmid & Partner  
Engineering AG  
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst  
C Service suisse d'étalonnage  
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S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client TMC

Certificate No: H3-6260\_Oct09

#### CALIBRATION CERTIFICATE

Object H3DV6 - SN:6260

Calibration procedure(s)  
QA CAL-03.v5 and QA CAL-25.v2  
Calibration procedure for H-field probes optimized for close near field evaluations in air

Calibration date: October 20, 2009

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature  $(22 \pm 3)^\circ\text{C}$  and humidity  $< 70\%$ .

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards          | ID #            | Cal Date (Certificate No.)     | Scheduled Calibration |
|----------------------------|-----------------|--------------------------------|-----------------------|
| Power meter E4419B         | GB41293874      | 1-Apr-09 (No. 217-01030)       | Apr-10                |
| Power sensor E4412A        | MY41495277      | 1-Apr-09 (No. 217-01030)       | Apr-10                |
| Power sensor E4412A        | MY41498087      | 1-Apr-09 (No. 217-01030)       | Apr-10                |
| Reference 3 dB Attenuator  | SN: S5054 (3c)  | 31-Mar-09 (No. 217-01026)      | Mar-10                |
| Reference 20 dB Attenuator | SN: S5086 (20b) | 31-Mar-09 (No. 217-01028)      | Mar-10                |
| Reference 30 dB Attenuator | SN: S5129 (30b) | 31-Mar-09 (No. 217-01027)      | Mar-10                |
| Reference Probe H3DV6      | SN: 6182        | 3-Oct-09 (No. H3-6182_Oct09)   | Oct-10                |
| DAE4                       | SN: 789         | 19-Dec-08 (No. DAE4-789_Dec08) | Dec-09                |

| Secondary Standards       | ID #         | Check Date (in house)             | Scheduled Check        |
|---------------------------|--------------|-----------------------------------|------------------------|
| RF generator HP 8648C     | US3842U01700 | 4-Aug-99 (in house check Oct-09)  | In house check: Oct-11 |
| Network Analyzer HP 8753E | US37390585   | 18-Oct-01 (in house check Oct-09) | In house check: Oct-10 |

| Calibrated by: | Name        | Function              | Signature |
|----------------|-------------|-----------------------|-----------|
|                | Marcel Fehr | Laboratory Technician |           |

| Approved by: | Name          | Function          | Signature |
|--------------|---------------|-------------------|-----------|
|              | Katja Pokovic | Technical Manager |           |

Issued: October 22, 2009

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

# TA Technology (Shanghai) Co., Ltd.

## Test Report

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Calibration Laboratory of  
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Engineering AG  
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst  
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S Servizio svizzero di taratura  
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

### Glossary:

|                        |  |
|------------------------|--|
| NORM $x,y,z$           | sensitivity in free space  |
| DCP                    | diode compression point  |
| CF                     | crest factor (1/duty_cycle) of the RF signal   |
| A, B, C                | modulation dependent linearization parameters  |
| Polarization $\varphi$ | $\varphi$ rotation around probe axis   |
| Polarization $\beta$   | $\beta$ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\beta = 0$ is normal to probe axis |
| Connector Angle        | information used in DASY system to align probe sensor X to the robot coordinate system   |

### Calibration is Performed According to the Following Standards:

- a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

### Methods Applied and Interpretation of Parameters:

- *NORM $x,y,z$* : Assessed for E-field polarization  $\beta = 0$  for XY sensors and  $\beta = 90$  for Z sensor ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide).
- *X,Y,Z(f)\_a0a1a2=X,Y,Z\_a0a1a2\*frequency\_response* (see Frequency Response Chart).
- *DCPx,y,z*: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- *Ax,y,z; Bx,y,z; Cx,y,z* are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media.
- *Spherical isotropy (3D deviation from isotropy)*: in a locally homogeneous field realized using an open waveguide setup.
- *Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- *Connector Angle*: The angle is assessed using the information gained by determining the *X\_a0a1a2* (no uncertainty required).

**TA Technology (Shanghai) Co., Ltd.**  
**Test Report**

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H3DV6 SN:6260

October 20, 2009

# Probe H3DV6

## SN:6260

|                  |                   |
|------------------|-------------------|
| Manufactured:    | September 7, 2007 |
| Last calibrated: | December 13, 2007 |
| Recalibrated:    | October 20, 2009  |

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

# TA Technology (Shanghai) Co., Ltd.

## Test Report

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H3DV6 SN:6260

October 20, 2009

### DASY - Parameters of Probe: H3DV6 SN:6260

#### Basic Calibration Parameters

|                       |    | Sensor X | Sensor Y | Sensor Z | Unc (k=2) |
|-----------------------|----|----------|----------|----------|-----------|
| Norm (A/m / ∛(μV))    | a0 | 2.47E-3  | 2.49E-3  | 2.95E-3  | ± 10.1%   |
| Norm (A/m / ∛(μV))    | a1 | -2.97E-5 | 5.62E-6  | -4.47E-5 | ± 10.1%   |
| Norm (A/m / ∛(μV))    | a2 | 4.84E-5  | 4.36E-5  | 6.01E-5  | ± 10.1%   |
| DCP (mV) <sup>A</sup> |    | 84.5     | 90.3     | 83.9     |           |

#### Modulation Calibration Parameters

| UID   | Communication System Name | PAR  |             | A<br>dB              | B<br>dBuV            | C                    | VR<br>mV          | Unc<br>(k=2) |
|-------|---------------------------|------|-------------|----------------------|----------------------|----------------------|-------------------|--------------|
| 10000 | CW                        | 0.00 | X<br>Y<br>Z | 0.00<br>0.00<br>0.00 | 0.00<br>0.00<br>0.00 | 1.00<br>1.00<br>1.00 | 300<br>300<br>300 | ± 1.5%       |

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>A</sup> numerical linearization parameter: uncertainty not required

**TA Technology (Shanghai) Co., Ltd.**  
**Test Report**

Report No. RZA1103-0408HAC01

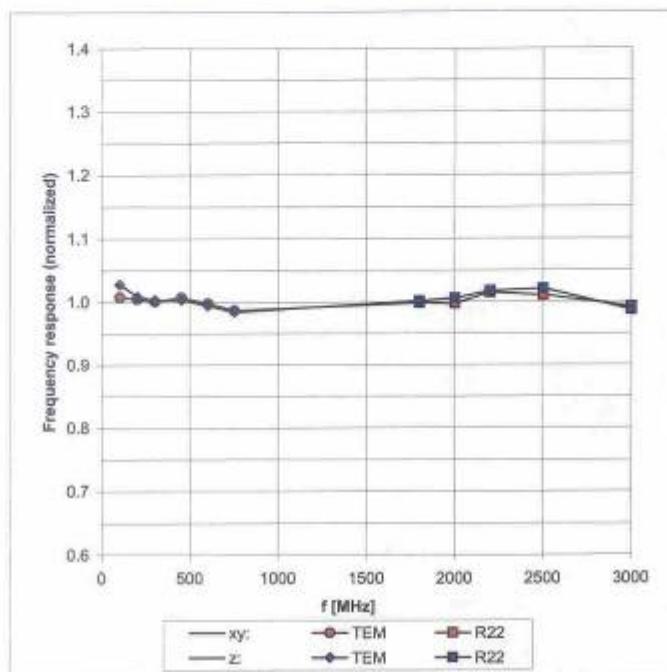
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H3DV6 SN:6260

October 20, 2009

**Frequency Response of H-Field**

(TEM-Cell:ifi110 EXX, Waveguide R22)



Uncertainty of Frequency Response of H-field:  $\pm 6.3\%$  ( $k=2$ )

# TA Technology (Shanghai) Co., Ltd. Test Report

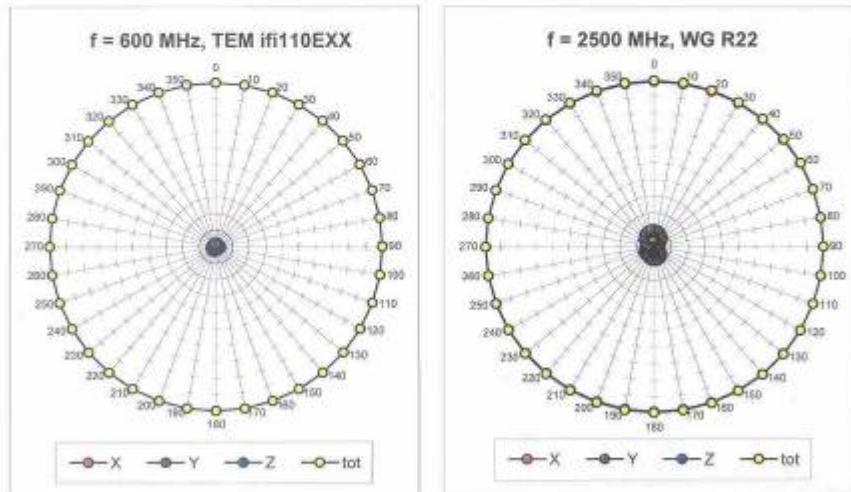
Report No. RZA1103-0408HAC01

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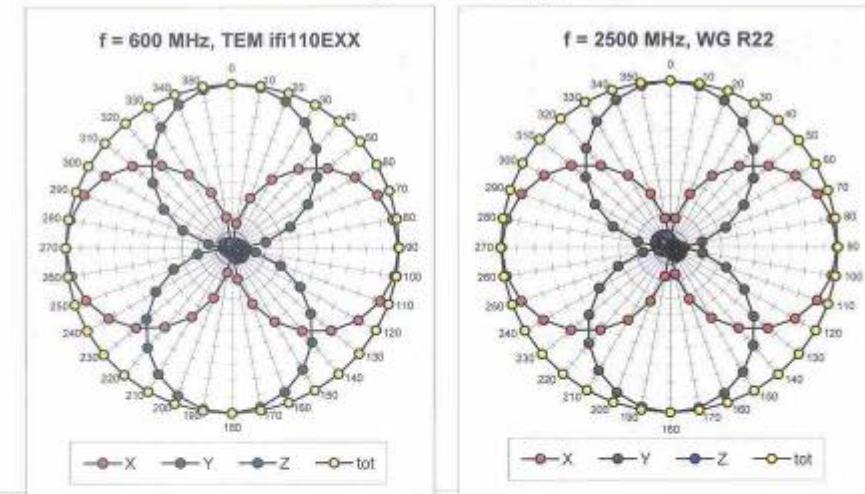
H3DV6 SN:6260

October 20, 2009

## Receiving Pattern ( $\phi$ ), $\theta = 90^\circ$



## Receiving Pattern ( $\phi$ ), $\theta = 0^\circ$



**TA Technology (Shanghai) Co., Ltd.**  
**Test Report**

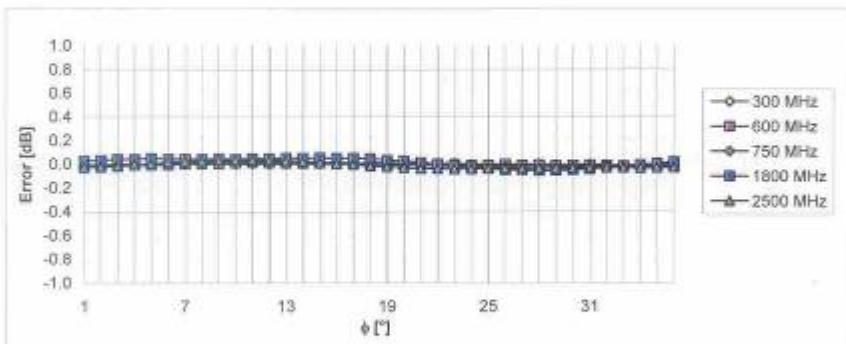
Report No. RZA1103-0408HAC01

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H3DV6 SN:6260

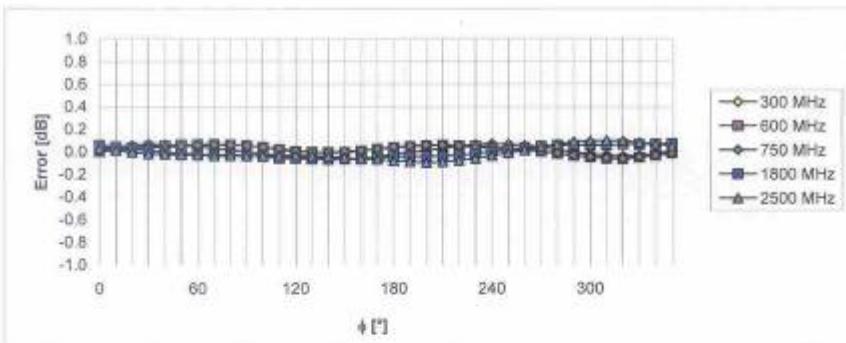
October 20, 2009

**Receiving Pattern ( $\phi$ ),  $\vartheta = 90^\circ$**



Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )

**Receiving Pattern ( $\phi$ ),  $\vartheta = 0^\circ$**



Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )

**TA Technology (Shanghai) Co., Ltd.**  
**Test Report**

Report No. RZA1103-0408HAC01

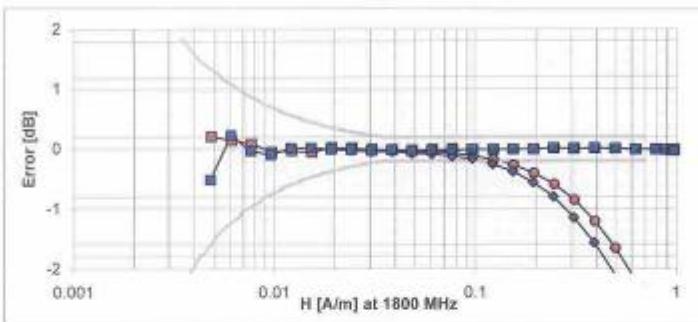
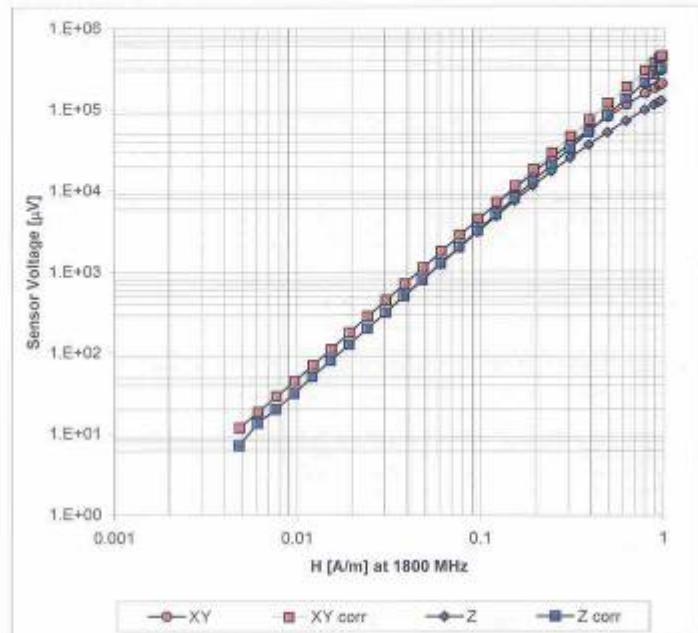
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H3DV6 SN:6260

October 20, 2009

**Dynamic Range f(H-field)**

(Waveguide R22, f = 1800 MHz)



Uncertainty of Linearity Assessment:  $\pm 0.6\%$  ( $k=2$ )

**TA Technology (Shanghai) Co., Ltd.**  
**Test Report**

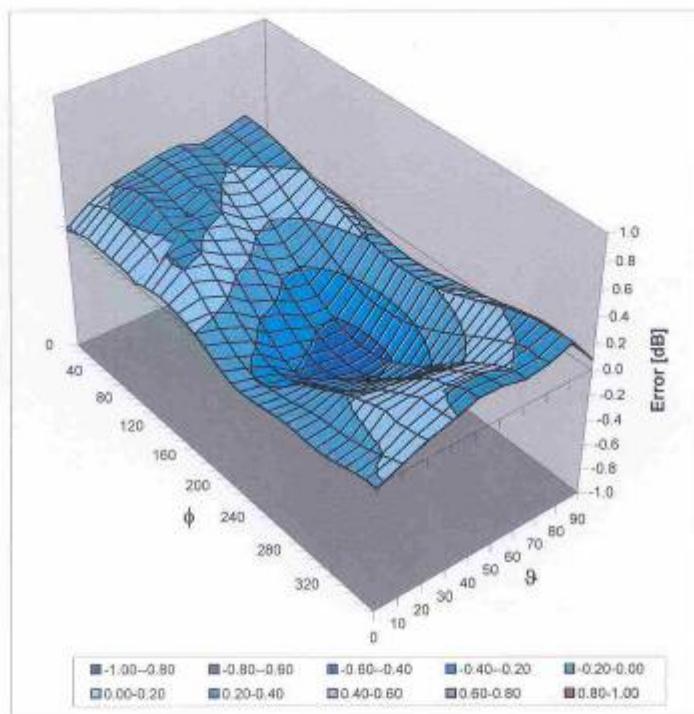
Report No. RZA1103-0408HAC01

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H3DV6 SN:6260

October 20, 2009

**Deviation from Isotropy in Air**  
**Error ( $\phi, \theta$ ), f = 900 MHz**



Uncertainty of Spherical Isotropy Assessment:  $\pm 2.6\%$  (k=2)

**TA Technology (Shanghai) Co., Ltd.**  
**Test Report**

Report No. RZA1103-0408HAC01

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H3DV6 SN:6260

October 20, 2009

**Other Probe Parameters**

|   |             |
|---|-------------|
| Sensor Arrangement                      | Rectangular |
| Connector Angle ("")                    | -154.1      |
| Mechanical Surface Detection Mode       | enabled     |
| Optical Surface Detection Mode          | disabled    |
| Probe Overall Length                    | 337 mm      |
| Probe Body Diameter                     | 10 mm       |
| Tip Length                              | 20 mm       |
| Tip Diameter                            | 6.0 mm      |
| Probe Tip to Sensor X Calibration Point | 3 mm        |
| Probe Tip to Sensor Y Calibration Point | 3 mm        |
| Probe Tip to Sensor Z Calibration Point | 3 mm        |

# TA Technology (Shanghai) Co., Ltd.

## Test Report

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ANNEX E: CD835V3 Dipole Calibration Certificate (SN: 1149)

**Calibration Laboratory of  
Schmid & Partner  
Engineering AG**  
Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates.

Accreditation No.: SCS 108

Client **Auden**

Certificates No: CD835V3-1149 Jan10

## CALIBRATION CERTIFICATE

Object CD835V3 - SN: 1149

Calibration procedure(s) QA CAL-20.v5  
Calibration procedure for dipoles in air

Calibration date: January 12, 2010

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). All calibrations have been conducted in the closed laboratory facility: environment temperature  $(22 \pm 3)^\circ\text{C}$  and humidity  $< 70\%$ .

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards         | ID #           | Cal Date (Certificate No.)        | Scheduled Calibration  |
|---------------------------|----------------|-----------------------------------|------------------------|
| Power meter EPM-442A      | GB37480704     | 06-Oct-09 (No. 217-01086)         | Oct-10                 |
| Power sensor HP 8461A     | US37292783     | 06-Oct-09 (No. 217-01086)         | Oct-10                 |
| Probe ER3DV6              | SN: 2336       | 30-Dec-09 (No. ER3-2336_Dec09)    | Dec-10                 |
| Probe H3DV6               | SN: 6065       | 30-Dec-09 (No. H3-6065_Dec09)     | Dec-10                 |
| DAE4                      | SN: 781        | 30-Nov-09 (No. DAE4-781_Nov09)    | Nov-10                 |
| Secondary Standards       | ID #           | Check Date (in house)             | Scheduled Check        |
| Power meter Agilent 4419B | SN: GB42420191 | 09-Oct-09 (in house check Oct-09) | In house check: Oct-10 |
| Power sensor HP 8462H     | SN: 3318A09450 | 09-Oct-09 (in house check Oct-09) | In house check: Oct-10 |
| Power sensor HP 8462A     | SN: US37285597 | 09-Oct-09 (in house check Oct-09) | In house check: Oct-10 |
| Network Analyzer HP 8753E | US37380585     | 18-Oct-01 (in house check Oct-09) | In house check: Oct-10 |
| RF generator E4433B       | MY 41000675    | 03-Nov-04 (in house check Oct-09) | In house check: Oct-11 |

Calibrated by: Name Function  
Claudio Leutbler Laboratory Technician

Signature

Approved by: Katja Pokovic Technical Manager

Issued: January 19, 2010

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

# TA Technology (Shanghai) Co., Ltd.

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**Calibration Laboratory of**  
Schmid & Partner  
Engineering AG  
Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

### References

- [1] ANSI-C63.19-2006  
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [2] ANSI-C63.19-2007  
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

### Methods Applied and Interpretation of Parameters:

- **Coordinate System:** y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1, 2], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- **Measurement Conditions:** Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- **Antenna Positioning:** The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- **Feed Point Impedance and Return Loss:** These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminated by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- **E-field distribution:** E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1, 2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelism to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- **H-field distribution:** H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

# TA Technology (Shanghai) Co., Ltd.

## Test Report

### 1 Measurement Conditions

DASY system configuration, as far as not given on page 1.

|                                    |                  |                      |
|------------------------------------|------------------|----------------------|
| DASY Version                       | DASY5            | V5.2 B157            |
| DASY PP Version                    | SEMCAD X         | V14.0 B57            |
| Phantom                            | HAC Test Arch    | SD HAC P01 BA, #1070 |
| Distance Dipole Top - Probe Center | 10 mm            |                      |
| Scan resolution                    | dx, dy = 5 mm    | area = 20 x 180 mm   |
| Frequency                          | 835 MHz ± 1 MHz  |                      |
| Forward power at dipole connector  | 20.0 dBm = 100mW |                      |
| Input power drift                  | < 0.05 dB        |                      |

### 2 Maximum Field values

| H-field 10 mm above dipole surface | condition            | interpolated maximum |
|------------------------------------|----------------------|----------------------|
| Maximum measured                   | 100 mW forward power | 0.465 A/m            |

Uncertainty for H-field measurement: 8.2% (k=2)

| E-field 10 mm above dipole surface | condition            | interpolated maximum |
|------------------------------------|----------------------|----------------------|
| Maximum measured above high end-   | 100 mW forward power | 170.7 V/m            |
| Maximum measured above low end     | 100 mW forward power | 162.6 V/m            |
| Averaged maximum above arm         | 100 mW forward power | 166.7 V/m            |

Uncertainty for E-field measurement: 12.8% (k=2)

### 3 Appendix

#### 3.1 Antenna Parameters

| Frequency | Return Loss | Impedance            |
|-----------|-------------|----------------------|
| 800 MHz   | 16.4 dB     | ( 43.4 - j12.6 ) Ohm |
| 835 MHz   | 25.5 dB     | ( 49.5 + j5.3 ) Ohm  |
| 900 MHz   | 16.6 dB     | ( 55.7 - j14.8 ) Ohm |
| 950 MHz   | 23.5 dB     | ( 45.4 + j4.4 ) Ohm  |
| 960 MHz   | 16.8 dB     | ( 48.6 + j14.4 ) Ohm |

#### 3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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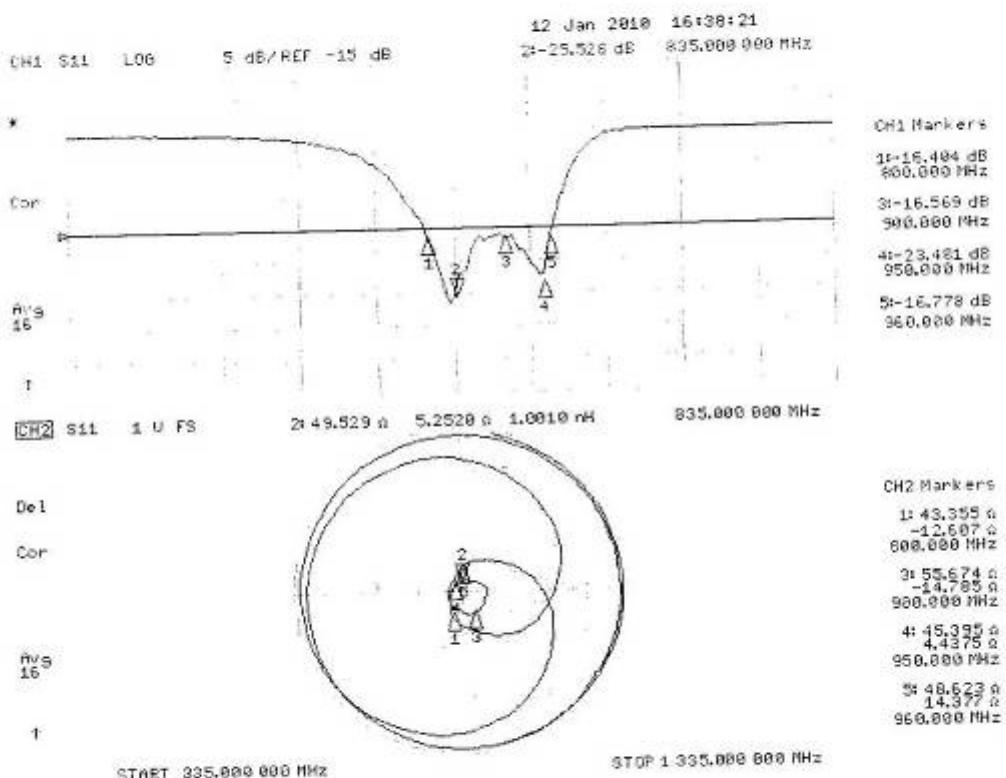
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### 3.3 Measurement Sheets

#### 3.3.1 Return Loss and Smith Chart



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### 3.3.2 DASY4 H-field Result

Date/Time: 12.01.2010 12:23:55

Test Laboratory: SPEAG Lab2

HAC RF\_CD835\_1149\_100112\_H\_CL

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1149

Communication System: CW; Frequency: 835 MHz

Medium parameters used:  $\sigma = 0 \text{ mho/m}$ ,  $\epsilon_r = 1$ ;  $\rho = 1 \text{ kg/m}^3$

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: H3DV6 - SN6065; Calibrated: 30.12.2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 30.11.2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY5, V5.2 Build 157; SEMCAD X Version 14.0 Build 57

### Dipole H-Field measurement @ 835MHz/H Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1):

Measurement grid:  $dx=5\text{mm}$ ,  $dy=5\text{mm}$

Maximum value of peak Total field = 0.465 A/m

Probe Modulation Factor = 1

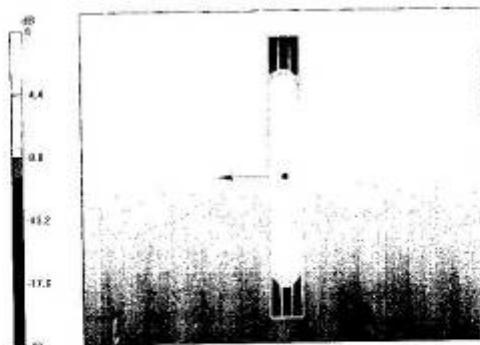
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.495 A/m; Power Drift = -0.012 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

| Grid 1<br><b>0.395</b><br><b>M4</b> | Grid 2<br><b>0.411</b><br><b>M4</b> | Grid 3<br><b>0.381</b><br><b>M4</b> |
|-------------------------------------|-------------------------------------|-------------------------------------|
| Grid 4<br><b>0.446</b><br><b>M4</b> | Grid 5<br><b>0.465</b><br><b>M4</b> | Grid 6<br><b>0.433</b><br><b>M4</b> |
| Grid 7<br><b>0.394</b><br><b>M4</b> | Grid 8<br><b>0.414</b><br><b>M4</b> | Grid 9<br><b>0.388</b><br><b>M4</b> |



0 dB = 0.465 A/m

# TA Technology (Shanghai) Co., Ltd.

## Test Report

Report No. RZA1103-0408HAC01

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### 3.3.3 DASY4 E-field Result

Date/Time: 12.01.2010 14:55:38

Test Laboratory: SPEAG Lab2

HAC RF\_CD835\_1149\_100112\_E\_CL

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1149

Communication System: CW; Frequency: 835 MHz

Medium parameters used:  $\sigma = 0 \text{ mho/m}$ ,  $\epsilon_r = 1$ ;  $\rho = 1000 \text{ kg/m}^3$

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 30.12.2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 30.11.2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY5, V5.2 Build 157; SEMCAD X Version 14.0 Build 57

### Dipole E-Field measurement @ 835MHz/E Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm 2/Hearing Aid Compatibility Test (41x361x1):

Measurement grid:  $dx=5\text{mm}$ ,  $dy=5\text{mm}$

Maximum value of peak Total field = 170.7 V/m

Probe Modulation Factor = 1

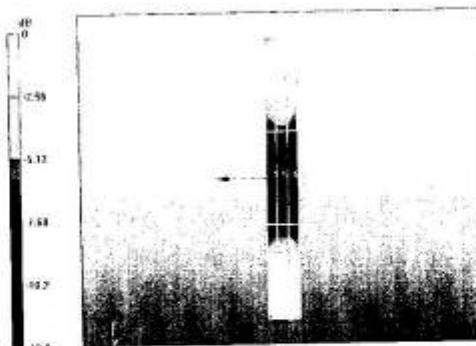
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 108.8 V/m; Power Drift = 0.013 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

| Grid 1<br><b>158.8</b><br><b>M4</b> | Grid 2<br><b>162.6</b><br><b>M4</b> | Grid 3<br><b>157.4</b><br><b>M4</b> |
|-------------------------------------|-------------------------------------|-------------------------------------|
| Grid 4<br><b>86.2</b><br><b>M4</b>  | Grid 5<br><b>88.2</b><br><b>M4</b>  | Grid 6<br><b>85.4</b><br><b>M4</b>  |
| Grid 7<br><b>158.6</b><br><b>M4</b> | Grid 8<br><b>170.7</b><br><b>M4</b> | Grid 9<br><b>169.5</b><br><b>M4</b> |



0 dB = 170.7V/m



# TA Technology (Shanghai) Co., Ltd.

## Test Report

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Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

### References

- [1] ANSI-C63.19-2006  
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [2] ANSI-C63.19-2007  
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

### Methods Applied and Interpretation of Parameters:

- **Coordinate System:** y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1, 2], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- **Measurement Conditions:** Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- **Antenna Positioning:** The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- **Feed Point Impedance and Return Loss:** These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminated by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- **E-field distribution:** E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1, 2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelism to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- **H-field distribution:** H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

# TA Technology (Shanghai) Co., Ltd.

## Test Report

### 1. Measurement Conditions

DASY system configuration, as far as not given on page 1.

|                                    |                      |                      |
|------------------------------------|----------------------|----------------------|
| DASY Version                       | DASY5                | V5.2 B157            |
| DASY PP Version                    | SEMCAD X             | V14.0 B57            |
| Phantom                            | HAC Test Arch        | SD HAC P01 BA, #1070 |
| Distance Dipole Top - Probe Center | 10 mm                |                      |
| Scan resolution                    | dx, dy = 5 mm        | area = 20 x 90 mm    |
| Frequency                          | 1880 MHz $\pm$ 1 MHz |                      |
| Forward power at dipole connector  | 20.0 dBm = 100mW     |                      |
| Input power drift                  | < 0.05 dB            |                      |

### 2. Maximum Field values

| H-field 10 mm above dipole surface | condition            | Interpolated maximum |
|------------------------------------|----------------------|----------------------|
| Maximum measured                   | 100 mW forward power | 0.475 A/m            |

Uncertainty for H-field measurement: 8.2% (k=2)

| E-field 10 mm above dipole surface | condition            | Interpolated maximum |
|------------------------------------|----------------------|----------------------|
| Maximum measured above high end    | 100 mW forward power | 142.9 V/m            |
| Maximum measured above low end     | 100 mW forward power | 139.7 V/m            |
| Averaged maximum above arm         | 100 mW forward power | 141.3 V/m            |

Uncertainty for E-field measurement: 12.8% (k=2)

### 3. Appendix

#### 3.1 Antenna Parameters

| Frequency       | Return Loss    | Impedance                  |
|-----------------|----------------|----------------------------|
| 1710 MHz        | 18.8 dB        | ( 47.5 + j10.9 ) Ohm       |
| <b>1880 MHz</b> | <b>21.2 dB</b> | <b>( 51.5 + j8.7 ) Ohm</b> |
| 1900 MHz        | 21.8 dB        | ( 54.4 + j7.3 ) Ohm        |
| 1950 MHz        | 26.4 dB        | ( 54.9 - j1.1 ) Ohm        |
| 2000 MHz        | 20.0 dB        | ( 41.0 - j0.8 ) Ohm        |

#### 3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

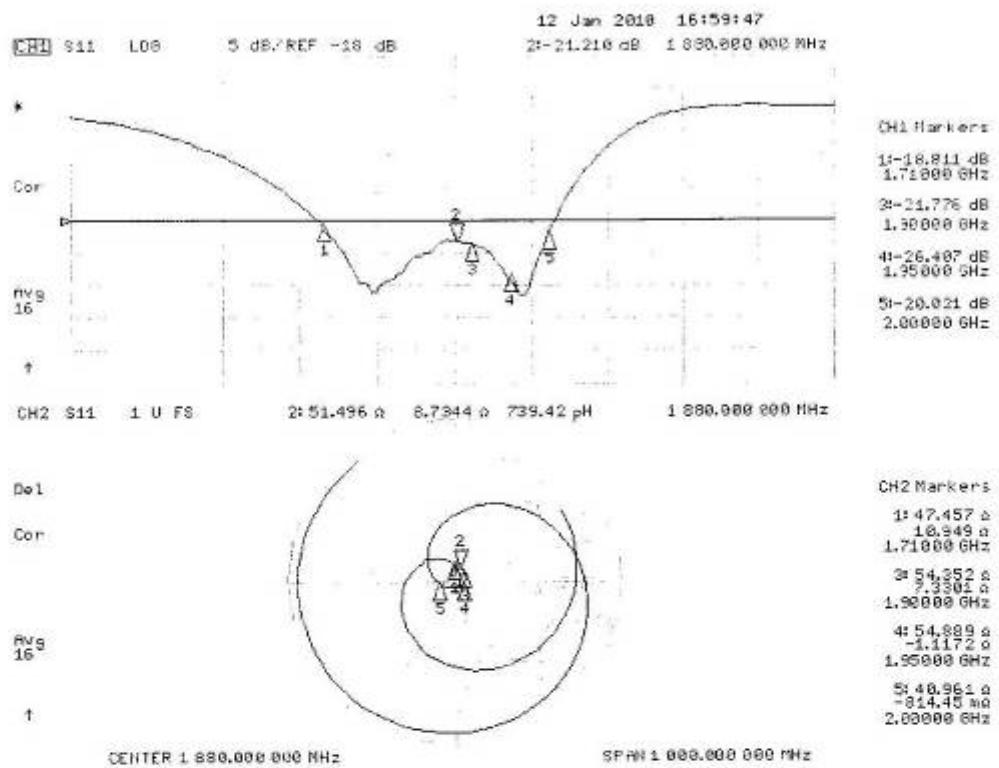
After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

# TA Technology (Shanghai) Co., Ltd.

## Test Report

### 3.3 Measurement Sheets

### 3.3.1 Return Loss and Smith Chart



# TA Technology (Shanghai) Co., Ltd.

## Test Report

### 3.3.2 DASY4 H-Field Result

Date/Time: 13.01.2010 12:17:00

Test Laboratory: SPEAG Lab2

HAC\_RF\_CD1880\_1135\_100113\_H\_CL

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1135

Communication System: CW; Frequency: 1880 MHz

Medium parameters used:  $\sigma = 0$  mho/m,  $c_0 = 1$ ;  $\rho = 1$  kg/m<sup>3</sup>

### Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

### **DASY5 Configuration:**

- Probe: H3DV6 - SN6065; Calibrated: 30.12.2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 S1781; Calibrated: 30.11.2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY5, V5.2 Build 157; SEMCAD X Version 14.0 Build 57

**Dipole H-Field measurement @ 1880MHz/H Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1):**

Measurement grid:  $dx=5\text{mm}$ ,  $dy=5\text{mm}$

Maximum value of peak Total field = 0.475 A/m

Maximum value of peak Four  
Probe Modulation Factor  $\approx 1$

Device Reference Point: 0, 0, -6.3 mm

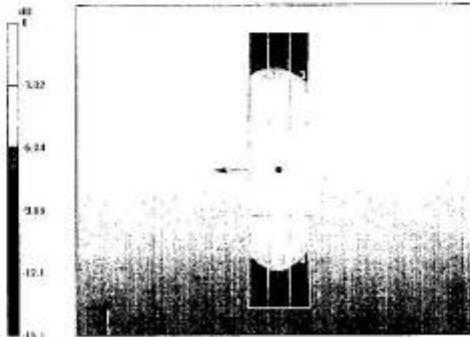
Reference Value = 0.503 A/m; Power Drift = -0.017 dB

#### Hearing Aid Non-Field Categories

#### Hearing Aid Near-Field Category: M2 (AWF 0 dB)

### Peak H-field in A/m

|                                     |                                     |                                     |
|-------------------------------------|-------------------------------------|-------------------------------------|
| Grid 1<br><b>0.421</b><br><b>M2</b> | Grid 2<br><b>0.436</b><br><b>M2</b> | Grid 3<br><b>0.410</b><br><b>M2</b> |
| Grid 4<br><b>0.458</b><br><b>M2</b> | Grid 5<br><b>0.475</b><br><b>M2</b> | Grid 6<br><b>0.447</b><br><b>M2</b> |
| Grid 7<br><b>0.412</b><br><b>M2</b> | Grid 8<br><b>0.431</b><br><b>M2</b> | Grid 9<br><b>0.407</b><br><b>M2</b> |



$$0 \text{ dB} = 0.475 \text{ A/m}$$

# TA Technology (Shanghai) Co., Ltd.

## Test Report

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### 3.3.3 DASY4 E-Field Result

Date/Time: 13.01.2010 13:42:51

Test Laboratory: SPEAG Lab2

**HAC\_RF\_CD1880\_1135\_100113\_E\_CL**

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1135

Communication System: CW; Frequency: 1880 MHz

Medium parameters used:  $\sigma = 0 \text{ mho/m}$ ,  $\epsilon_r = 1$ ;  $\rho = 1000 \text{ kg/m}^3$

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 30.12.2009
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 30.11.2009
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY5, V5.2 Build 157; SEMCAD X Version 14.0 Build 57

#### Dipole E-Field measurement @ 1880MHz/E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1):

Measurement grid:  $dx=5\text{mm}$ ,  $dy=5\text{mm}$

Maximum value of peak Total field = 142.9 V/m

Probe Modulation Factor = 1

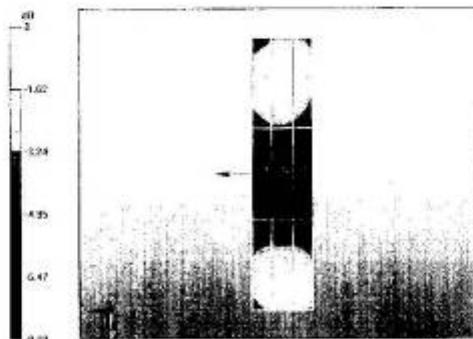
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 162.1 V/m; Power Drift = -0.010 dB

**Hearing Aid Near-Field Category: M2 (AWF 0 dB)**

Peak E-field in V/m

| Grid 1<br><b>136.2</b><br><b>M2</b> | Grid 2<br><b>139.7</b><br><b>M2</b> | Grid 3<br><b>135.5</b><br><b>M2</b> |
|-------------------------------------|-------------------------------------|-------------------------------------|
| Grid 4<br><b>93.1</b><br><b>M3</b>  | Grid 5<br><b>95.1</b><br><b>M3</b>  | Grid 6<br><b>90.7</b><br><b>M3</b>  |
| Grid 7<br><b>135.2</b><br><b>M2</b> | Grid 8<br><b>142.9</b><br><b>M2</b> | Grid 9<br><b>140.6</b><br><b>M2</b> |



0 dB = 142.9V/m

# TA Technology (Shanghai) Co., Ltd.

## Test Report

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### ANNEX G: DAE4 Calibration Certificate

Calibration Laboratory of  
Schmid & Partner  
Engineering AG  
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst  
C Service suisse d'étalonnage  
S Servizio svizzero di taratura  
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client TA - SH (Auden)

Certificate No.: DAE4-871\_Nov10

#### CALIBRATION CERTIFICATE

Object DAE4 - SD 000 D04 BJ - SN: 871

Calibration procedure(s) QA CAL-06.v22  
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: November 18, 2010

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature  $(22 \pm 3)^\circ\text{C}$  and humidity  $< 70\%$ .

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards             | ID #               | Cal Date (Certificate No.) | Scheduled Calibration  |
|-------------------------------|--------------------|----------------------------|------------------------|
| Keithley Multimeter Type 2001 | SN: 0810278        | 28-Sep-10 (No:10376)       | Sep-11                 |
| Secondary Standards           | ID #               | Check Date (in house)      | Scheduled Check        |
| Calibrator Box V1.1           | SE UMS 006 AB 1004 | 07-Jun-10 (in house check) | In house check: Jun-11 |

Calibrated by: Name Andrea Guntli Function Technician Signature

Approved by: Name Finn Bornholt Function R&D Director Signature

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Issued: November 18, 2010

# TA Technology (Shanghai) Co., Ltd.

## Test Report

Report No. RZA1103-0408HAC01

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**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

### Glossary

|                 |   |
|-----------------|---|
| DAE             | data acquisition electronics  |
| Connector angle | information used in DASY system to align probe sensor X to the robot coordinate system. |

### Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
  - **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
  - **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
  - **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
  - **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
  - **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
  - **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
  - **Input resistance:** Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
  - **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
  - **Power consumption:** Typical value for information. Supply currents in various operating modes.

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### DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB =  $6.1\mu\text{V}$ , full range =  $-100...+300\text{ mV}$

Low Range: 1LSB =  $61\text{nV}$ , full range =  $-1.....+3\text{mV}$

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

| Calibration Factors | X                                 | Y                                 | Z                                 |
|---------------------|-----------------------------------|-----------------------------------|-----------------------------------|
| High Range          | $404.757 \pm 0.1\% \text{ (k=2)}$ | $404.740 \pm 0.1\% \text{ (k=2)}$ | $405.181 \pm 0.1\% \text{ (k=2)}$ |
| Low Range           | $3.98219 \pm 0.7\% \text{ (k=2)}$ | $3.93489 \pm 0.7\% \text{ (k=2)}$ | $3.96831 \pm 0.7\% \text{ (k=2)}$ |

### Connector Angle

|   |                          |
|---|--------------------------|
| Connector Angle to be used in DASY system | $90.0^\circ \pm 1^\circ$ |
|---|--------------------------|

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**Appendix**

**1. DC Voltage Linearity**

| High Range |         | Reading (µV) | Difference (µV) | Error (%) |
|------------|---------|--------------|-----------------|-----------|
| Channel X  | + Input | 200001.2     | -1.56           | -0.00     |
| Channel X  | + Input | 20000.71     | 0.71            | 0.00      |
| Channel X  | - Input | -19997.87    | 1.63            | -0.01     |
| Channel Y  | + Input | 199994.3     | 1.99            | 0.00      |
| Channel Y  | + Input | 19998.92     | -1.08           | -0.01     |
| Channel Y  | - Input | -20000.26    | -0.76           | 0.00      |
| Channel Z  | + Input | 200009.2     | -1.04           | -0.00     |
| Channel Z  | + Input | 19998.70     | -1.10           | -0.01     |
| Channel Z  | - Input | -20000.16    | -0.76           | 0.00      |

| Low Range |         | Reading (µV) | Difference (µV) | Error (%) |
|-----------|---------|--------------|-----------------|-----------|
| Channel X | + Input | 2000.1       | 0.16            | 0.01      |
| Channel X | + Input | 199.58       | -0.52           | -0.26     |
| Channel X | - Input | -200.79      | -0.89           | 0.45      |
| Channel Y | + Input | 1999.9       | -0.03           | -0.00     |
| Channel Y | + Input | 199.45       | -0.55           | -0.27     |
| Channel Y | - Input | -200.31      | -0.41           | 0.21      |
| Channel Z | + Input | 2000.1       | 0.33            | 0.02      |
| Channel Z | + Input | 199.13       | -0.77           | -0.38     |
| Channel Z | - Input | -201.47      | -1.37           | 0.69      |

**2. Common mode sensitivity**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

|           | Common mode<br>Input Voltage (mV) | High Range<br>Average Reading (µV) | Low Range<br>Average Reading (µV) |
|-----------|-----------------------------------|------------------------------------|-----------------------------------|
| Channel X | 200                               | 14.25                              | 12.86                             |
|           | -200                              | -12.68                             | -14.21                            |
| Channel Y | 200                               | -10.04                             | -10.39                            |
|           | -200                              | 9.20                               | 9.17                              |
| Channel Z | 200                               | -0.85                              | -1.40                             |
|           | -200                              | -0.34                              | -0.31                             |

**3. Channel separation**

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

|           | Input Voltage (mV) | Channel X (µV) | Channel Y (µV) | Channel Z (µV) |
|-----------|--------------------|----------------|----------------|----------------|
| Channel X | 200                | -              | 2.85           | 0.69           |
| Channel Y | 200                | 2.41           | -              | 2.73           |
| Channel Z | 200                | 2.54           | 0.73           | -              |

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### 4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

|           | High Range (LSB) | Low Range (LSB) |
|-----------|------------------|-----------------|
| Channel X | 15920            | 15517           |
| Channel Y | 16171            | 16732           |
| Channel Z | 15803            | 16474           |

### 5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

|           | Average ( $\mu$ V) | min. Offset ( $\mu$ V) | max. Offset ( $\mu$ V) | Std. Deviation ( $\mu$ V) |
|-----------|--------------------|------------------------|------------------------|---------------------------|
| Channel X | 0.03               | -2.35                  | 0.86                   | 0.43                      |
| Channel Y | -0.50              | -1.49                  | -0.49                  | 0.38                      |
| Channel Z | -0.92              | -2.21                  | 0.14                   | 0.44                      |

### 6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

### 7. Input Resistance (Typical values for information)

|           | Zeroing (kOhm) | Measuring (MOhm) |
|-----------|----------------|------------------|
| Channel X | 200            | 200              |
| Channel Y | 200            | 200              |
| Channel Z | 200            | 200              |

### 8. Low Battery Alarm Voltage (Typical values for information)

| Typical values | Alarm Level (VDC) |
|----------------|-------------------|
| Supply (+ Vcc) | +7.9              |
| Supply (- Vcc) | -7.6              |

### 9. Power Consumption (Typical values for information)

| Typical values | Switched off (mA) | Stand by (mA) | Transmitting (mA) |
|----------------|-------------------|---------------|-------------------|
| Supply (+ Vcc) | +0.01             | +6            | +14               |
| Supply (- Vcc) | -0.01             | -8            | -9                |